



# Microfabrication activities at CERN

*Update on work related to Microchannel Cooling Plates*

Alessandro Mapelli



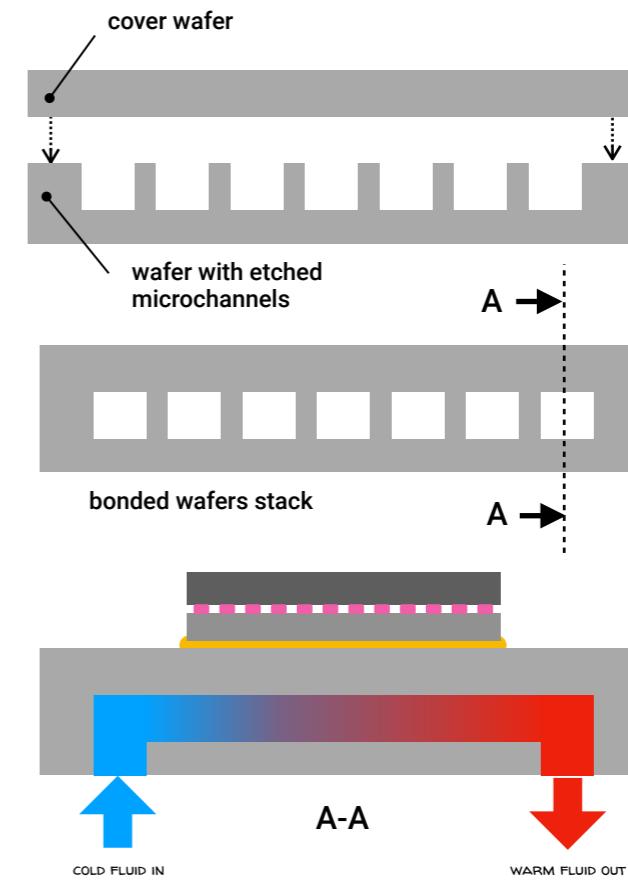
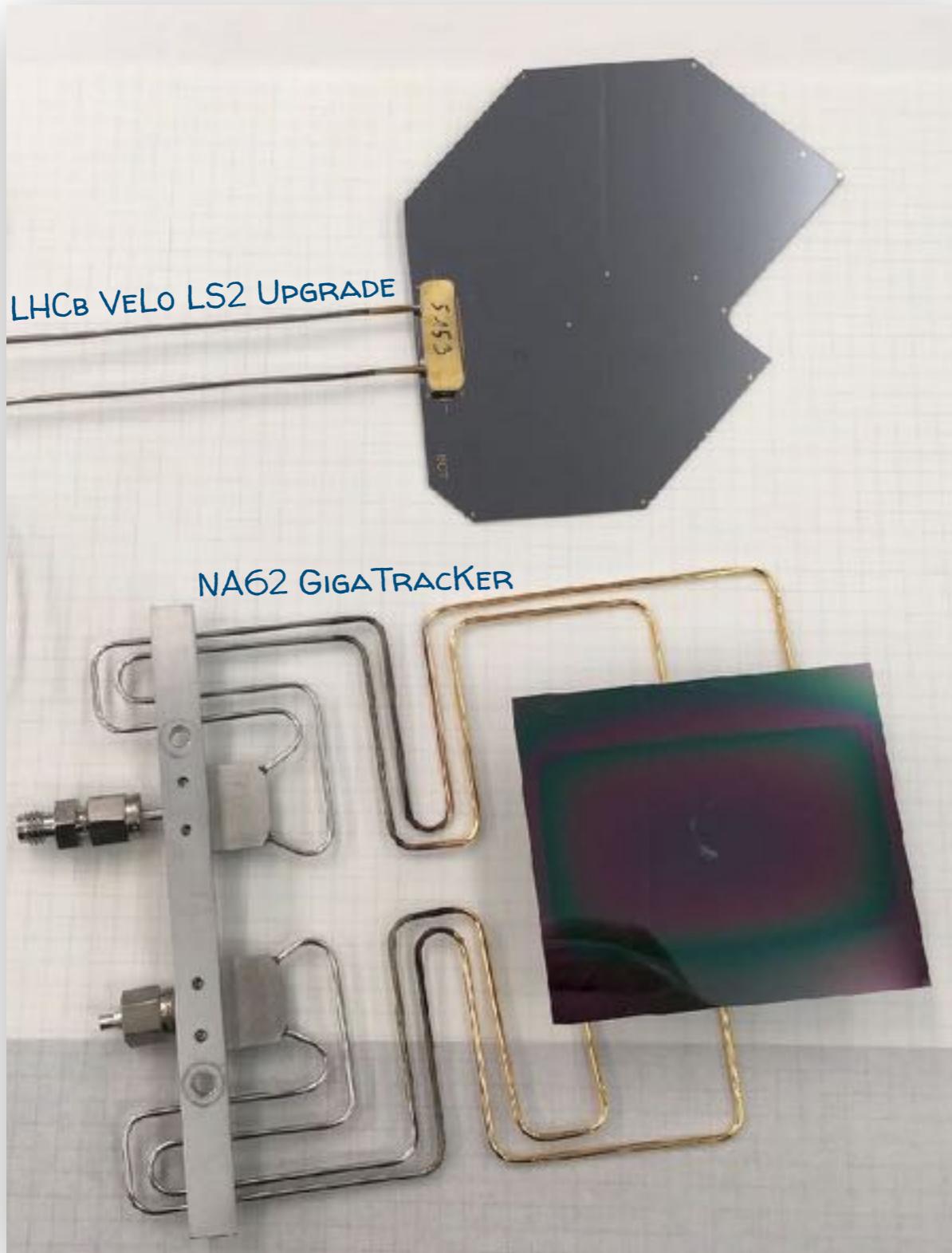
EP-DT  
Detector Technologies

100 µm

	Introduction and status of the final deliverables	Paolo Petagna
	Seminar Room II, St Annes College	15:30 - 15:45
	Plans for testing microchannel cooling for the new MCM-boards of TPC electronics in Pisa	Alippe assi
	Seminar Room II, St Annes College	15:45 - 16:00
16:00	New measurements on CO <sub>2</sub> boiling in mil- and micro- channels at CERN	Paolo Petagna
	Seminar Room II, St Annes College	16:00 - 16:15
	Status of the activities in Valencia	Gilberto Vittorini
	Seminar Room II, St Annes College	16:15 - 16:30
	Microfabrication activities at CERN	Alessandro Mapelli
	Seminar Room II, St Annes College	16:30 - 16:45
	Coffee Break	
	Salvador Trullén	16:45 - 17:00
17:00	Embedding microfluidics into microelectronics	Rizwanir Chagani
	Seminar Room II, St Annes College	17:00 - 17:15
	Silicon-based micro oscillating heat pipes for HEP and space applications	Timofee Pro
	Seminar Room II, St Annes College	17:15 - 17:30
	Silicon microchannel cooling frames for slave configurations	Massimo Angeletti
	Seminar Room II, St Annes College	17:30 - 17:45
	Status of the TB.3 activities in Oxford	Georg Wehrhauser
	Seminar Room II, St Annes College	17:45 - 18:00
18:00	VISIT TO THE NEW OXFORD LAB	Georg Wehrhauser
	Seminar Room II, St Annes College	18:00 - 18:30
19:00		



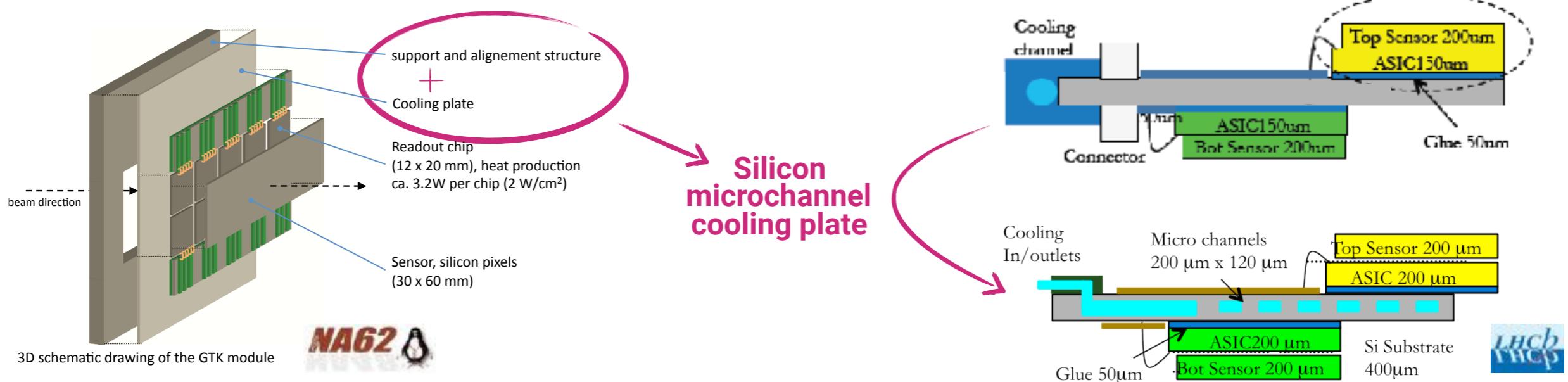
# silicon microchannel cooling plates



- No CTE mismatch
- Active and distributed cooling
  - Better temperature uniformity across sensor
- Low and uniform material budget
- Radiation resistance
- Great potential for integration
  - Same microfabrication techniques as sensors and microelectronics.
- Thermal Figure of Merit

$$TFM = \frac{T_{\text{sensor}} - T_{\text{fluid}}}{\text{power density}}$$

# NA62 GTK and LHCb VELO Upgrade

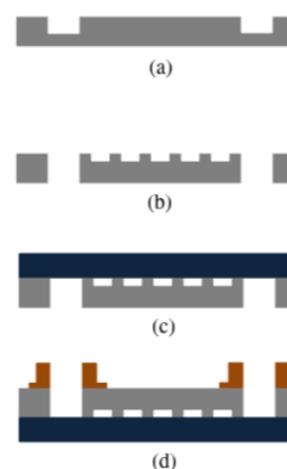


	NA62	LHCb
<b># of modules</b>	3	52 (2x 26)
<b>distance between modules</b>	~10 m	2.5 cm
<b>sensors</b>	hybrid pixel	hybrid pixel
<b>sensor size</b>	60 x 38 mm	43 x 15 mm
<b>sensors/module</b>	1	4 (2 on each side of plate)
<b>power dissipation (average)</b>	~2 W/cm <sup>2</sup>	~2 W/cm <sup>2</sup>
<b>coolant</b>	liquid C <sub>6</sub> F <sub>14</sub>	evap. CO <sub>2</sub>
<b>cooling pate thickness</b>	~200 µm	~500 µm
<b>operating temp. on sensor</b>	-10°C	> -20°C
<b>max. operating pressure</b>	~10 bars	~60 bars
<b>safety pressure</b>	~20 bars	~200 bars
<b>operation in vacuum</b>	primary vacuum of NA62	secondary vacuum of LHC
<b>distance to beam</b>	in the beam axis	5.1 mm

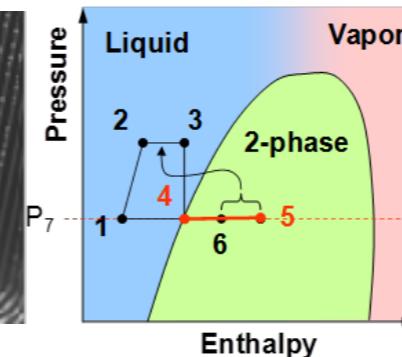
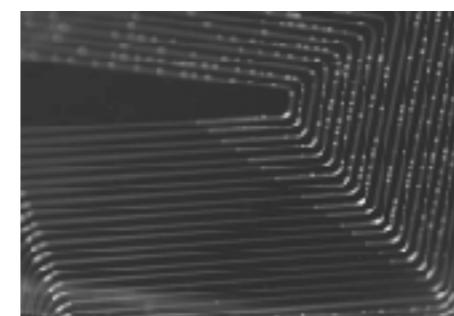
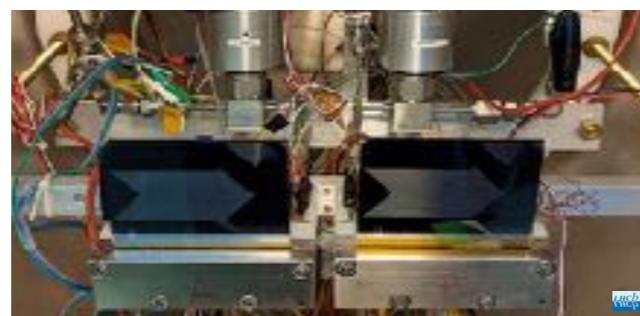
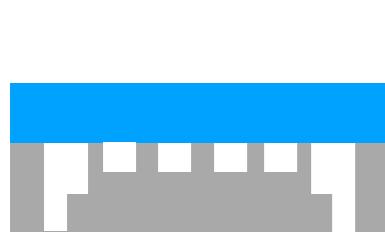
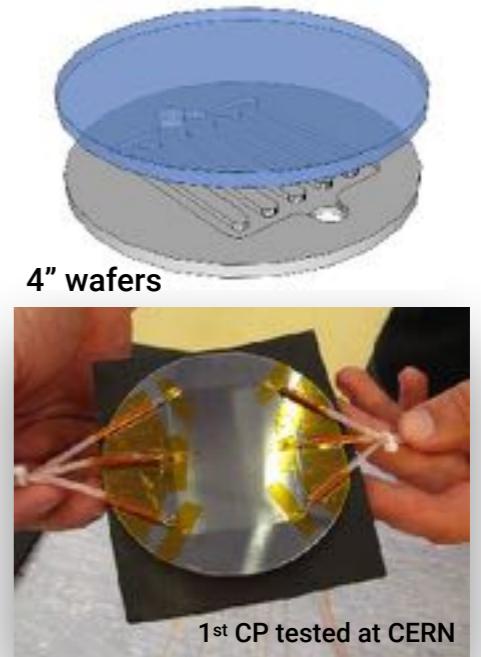
# “in-house” microfabrication processes



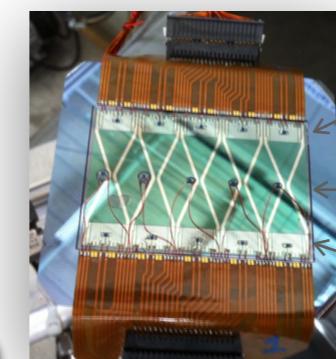
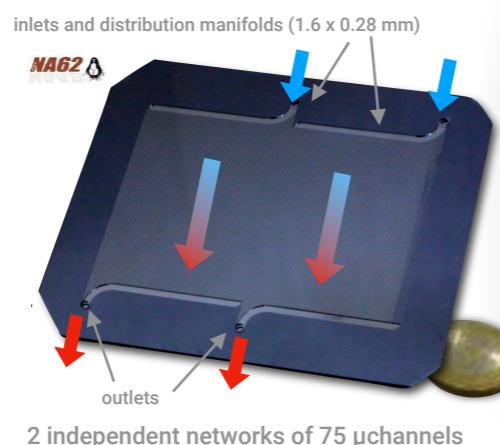
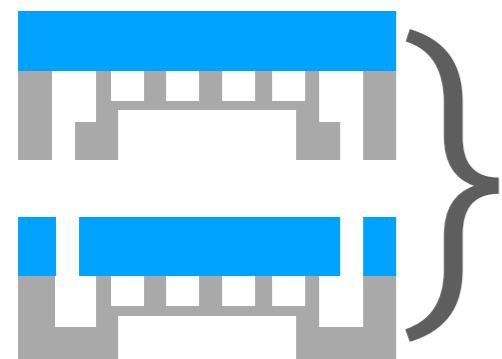
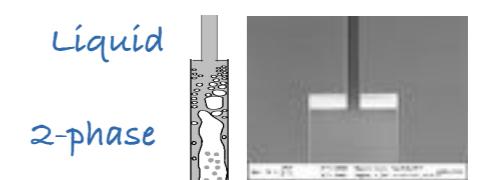
Process-flow developed at CERN for the first microchannel cooling plates



A. Mapelli et al. / Nuclear Physics B (Proc. Suppl.) 215 (2011) 349–352

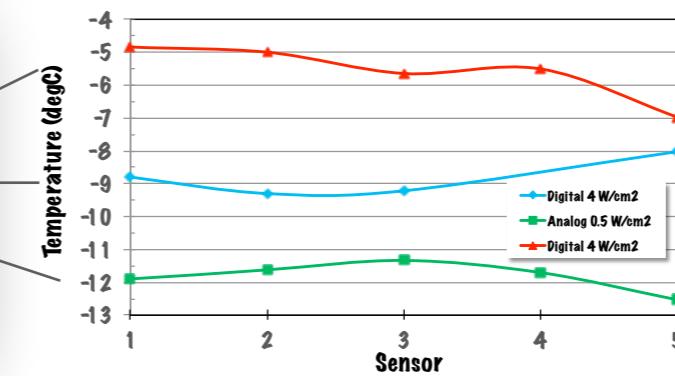


First demonstration of 2-phase  $\text{CO}_2$  circulation in silicon microchannels.



CP equipped with thermo-mechanical mockup of the hybrid detector

5



- Power dissipation
  - Digital Power 38 W
  - Analog Power 10 W
- Liquid  $\text{C}_6\text{F}_{14}$ 
  - 7g/s
  - -19°C at inlet

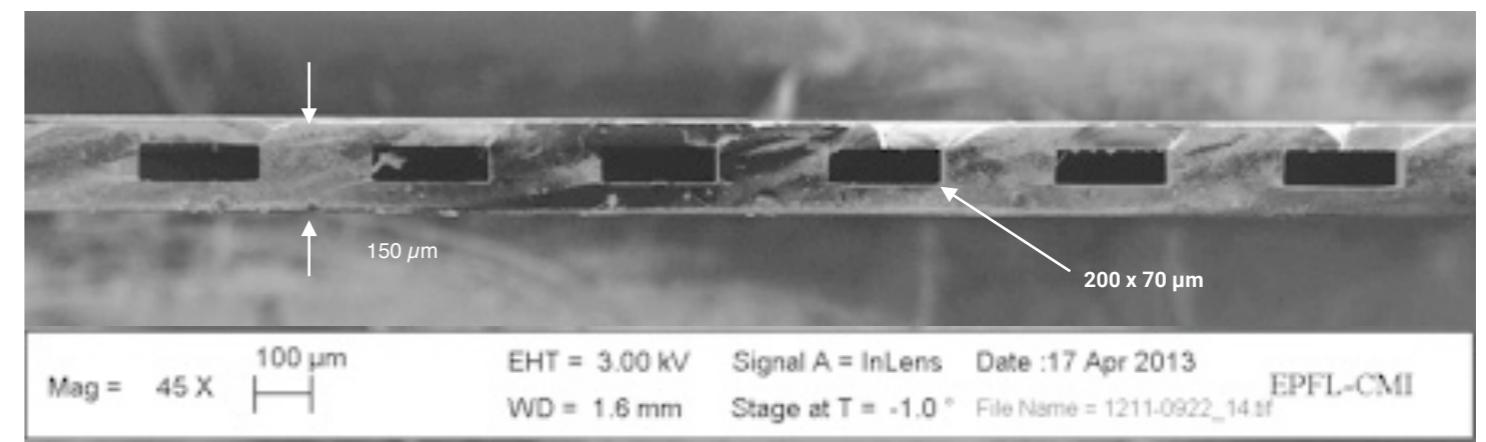
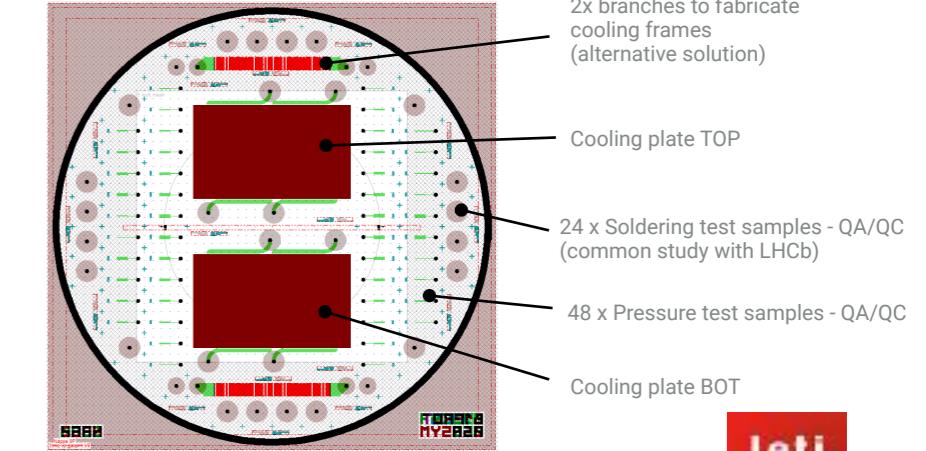
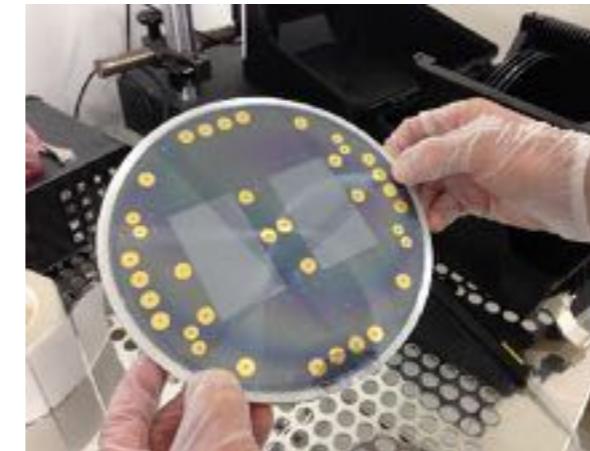
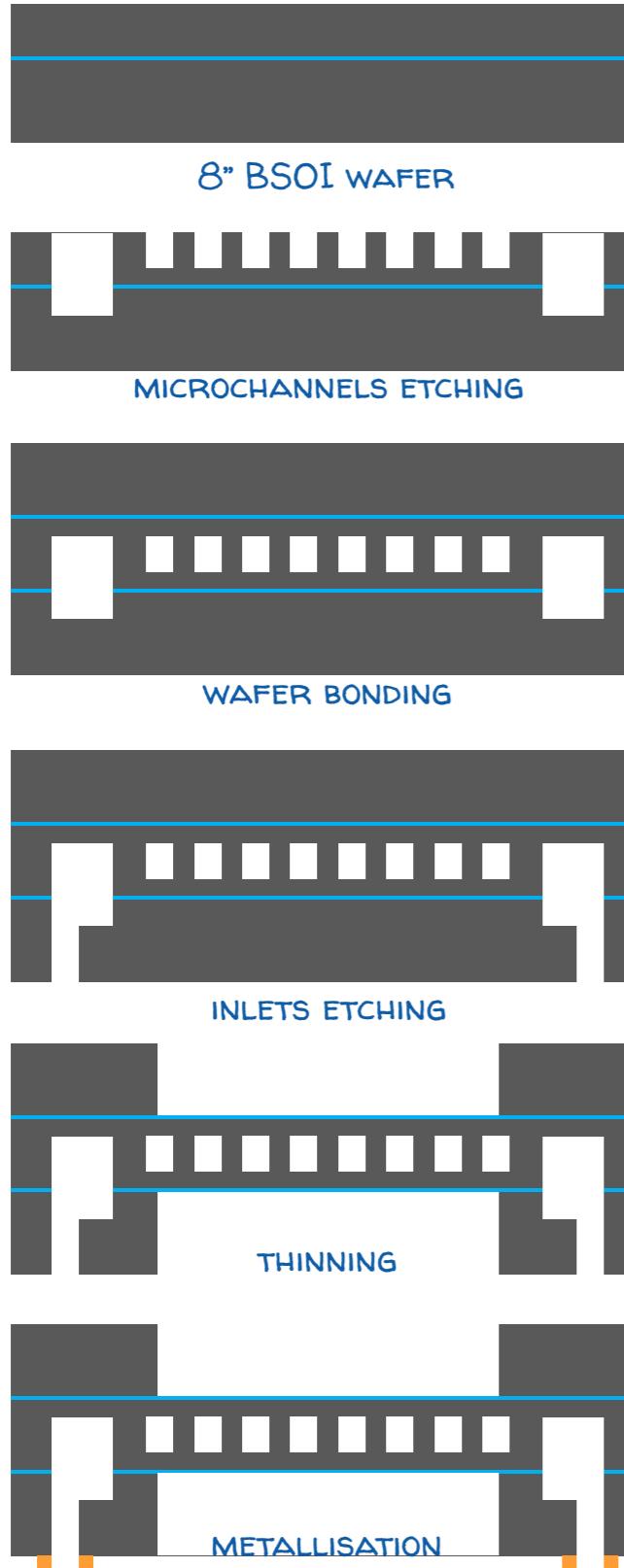


Alessandro Mapelli



4th Annual Meeting, 2-5 April 2019

# microfabrication of the GTK cooling plates

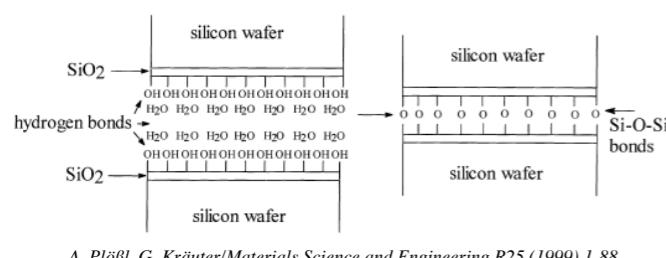


- Collaborative effort between CERN (ALICE, LHCb, NA62 and EP-DT) and external partners (CSEM, EPFL).
- Design by CERN EP-DT
- Prototypes fabricated by CERN EP-DT at EPFL-CMi on 4" wafers
- Pre-production series by IceMOS on 6" wafers
- Three batches fabricated at CEA-Leti on 8" wafers
- Fourth batch is under fabrication for the post-LS2 GTK modules.

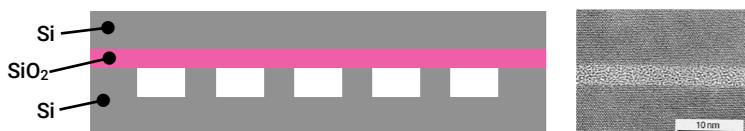
# Silicon direct wafer bonding

No intermediate layer such as eutectic metals or adhesives for the bonding

## Hydrophilic bonding



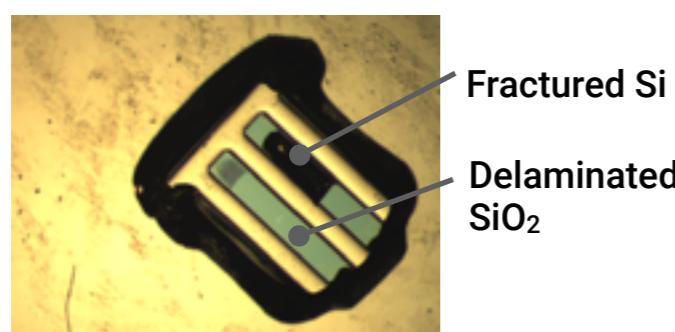
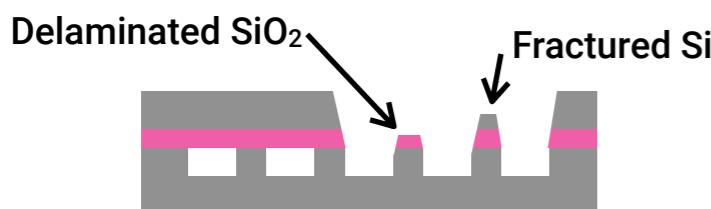
A. Plößl, G. Kräuter/Materials Science and Engineering R25 (1999) 1-88



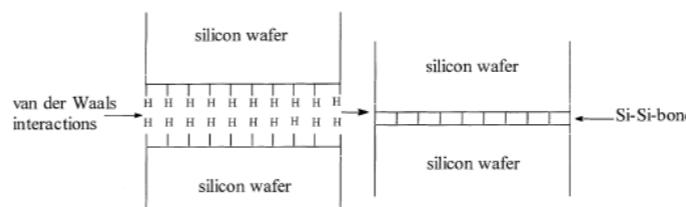
$T_{\text{anneal}} = 1050^\circ\text{C}$

$P_{\max} \sim 400$  bars

delamination + rupture



## Hydrophobic bonding



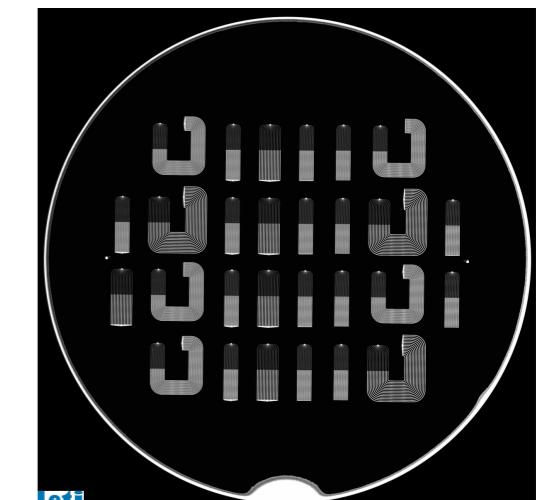
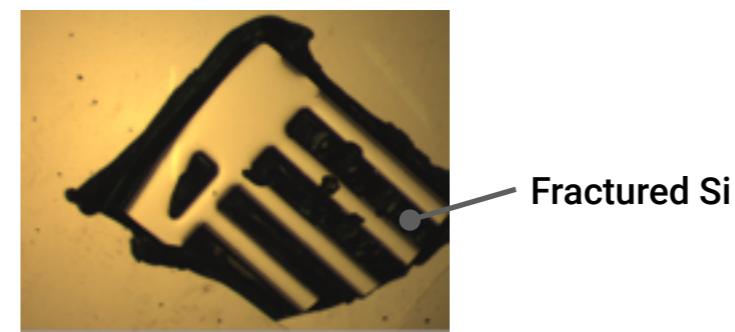
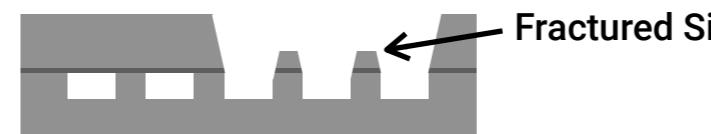
A. Plößl, G. Kräuter/Materials Science and Engineering R25 (1999) 1-88



$T_{\text{anneal}} = 1050^\circ\text{C}$

$P_{\max} \sim 700$  bars

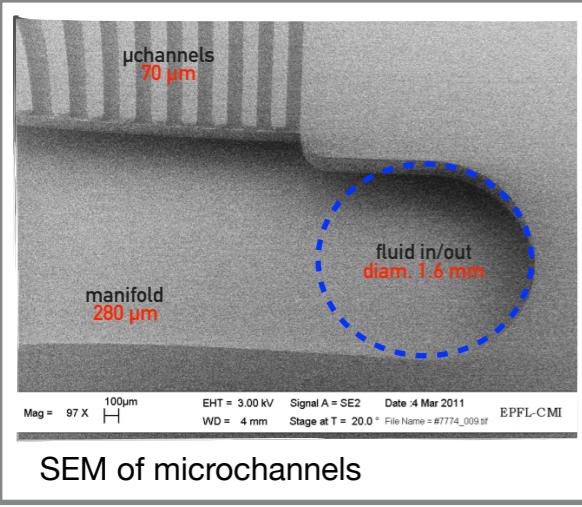
rupture without delamination



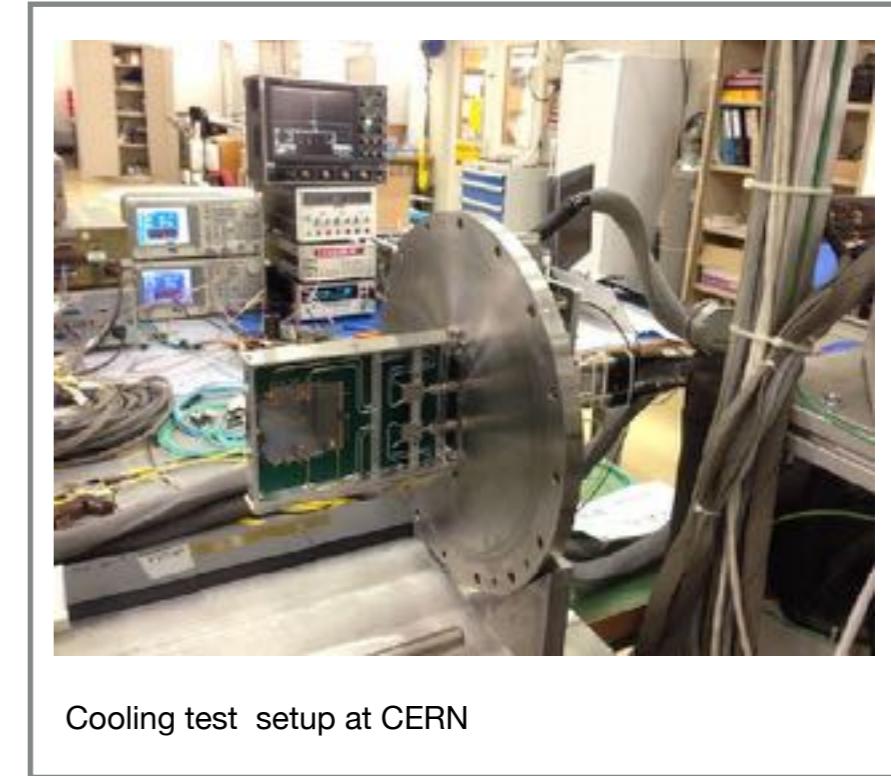
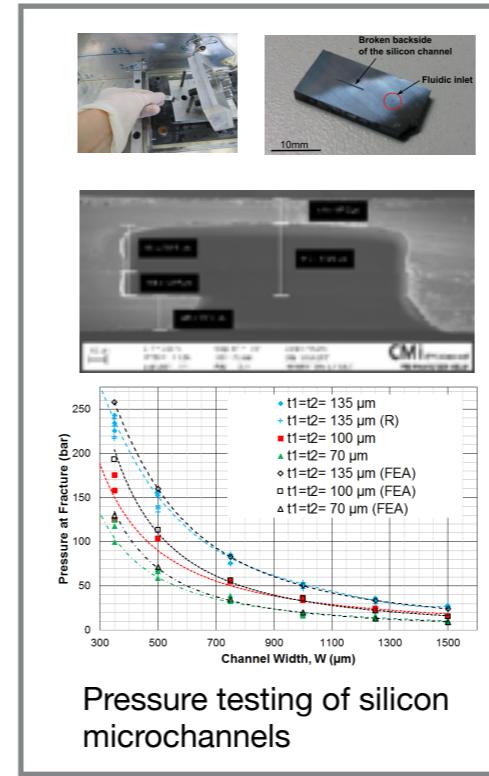
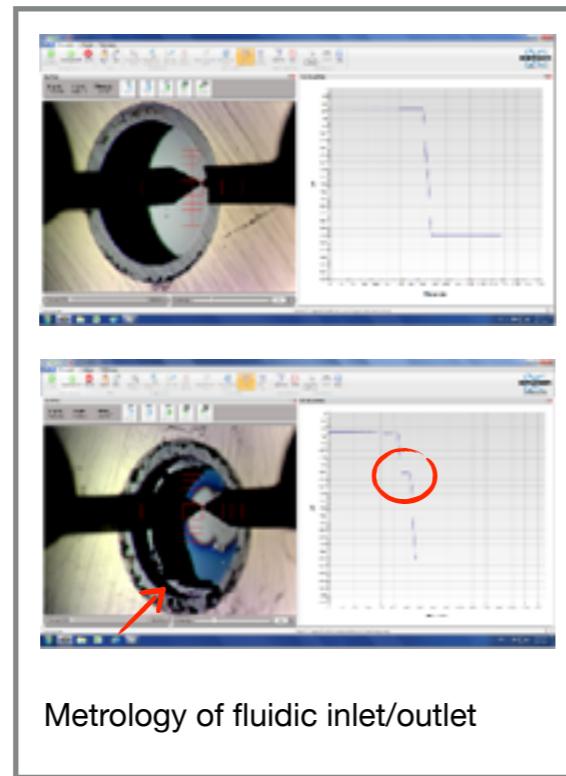
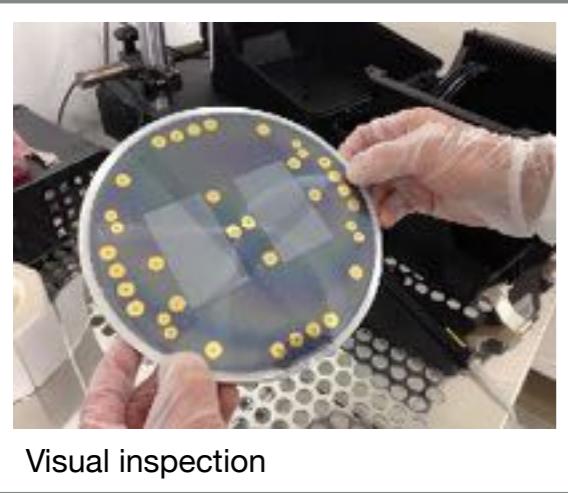
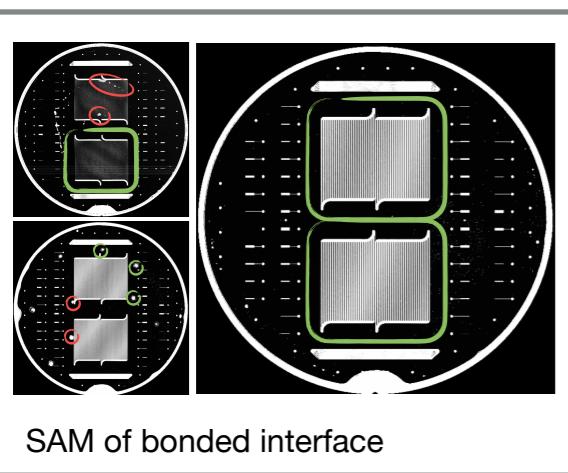
Scanning Acoustic Microscope image of bonded wafers with test structures.



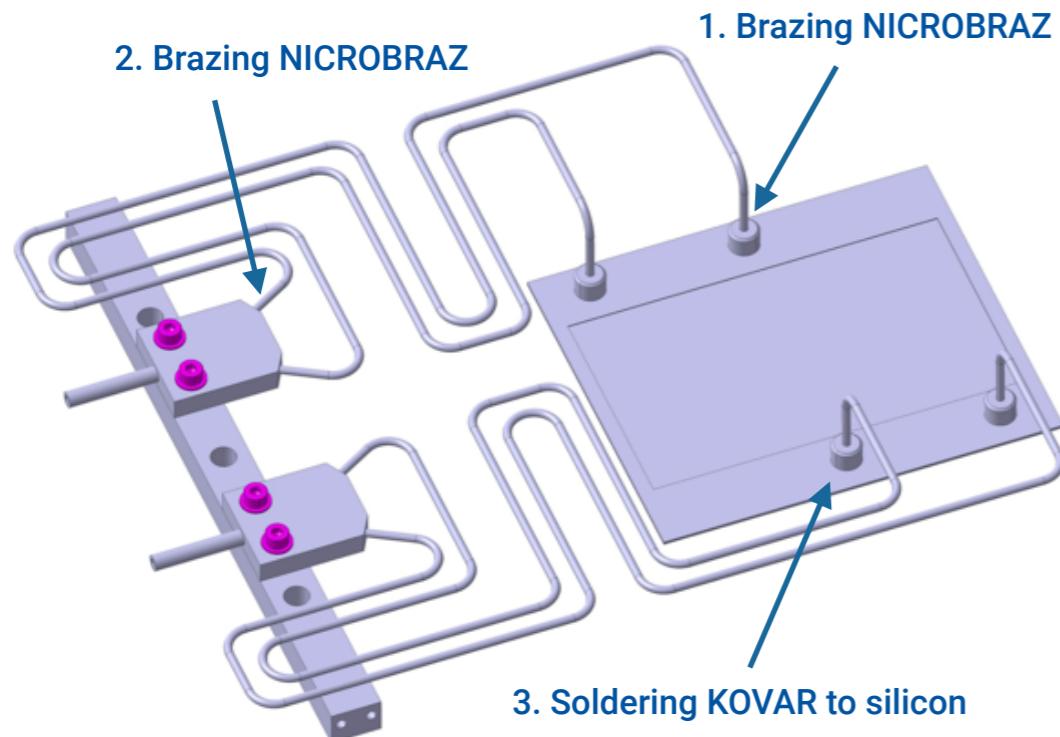
# QA/QC of the cooling plates



- Etching profiles of the microchannels.
- Scanning Acoustic Microscopy of bonded wafers.
- Visual inspection during tape-out.
- Metrology of cooling plates (Inlets and pools).
- Pressure tests on dedicated samples
  - 1500 μm wide cavities (manifolds) > 25 bars
  - 200 μm wide cavities (microchannels) > 200 bars
  - Soldering pads > 200 bars
- Pressure and temperature cycles on soldered cooling plate.



# Microfluidic system integration

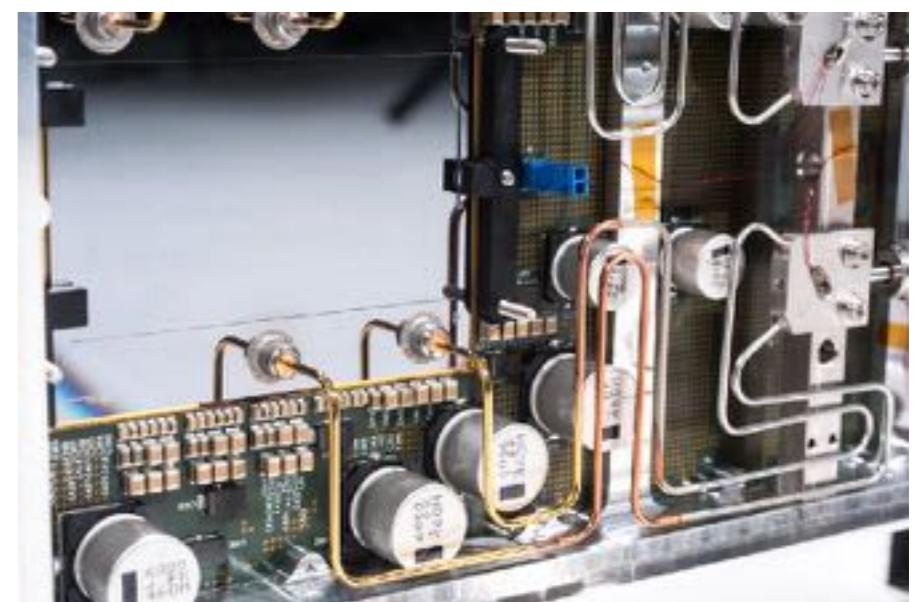
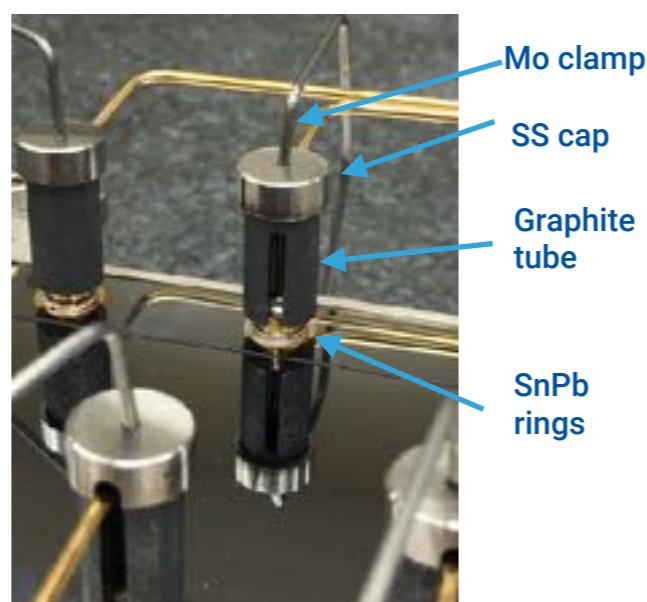
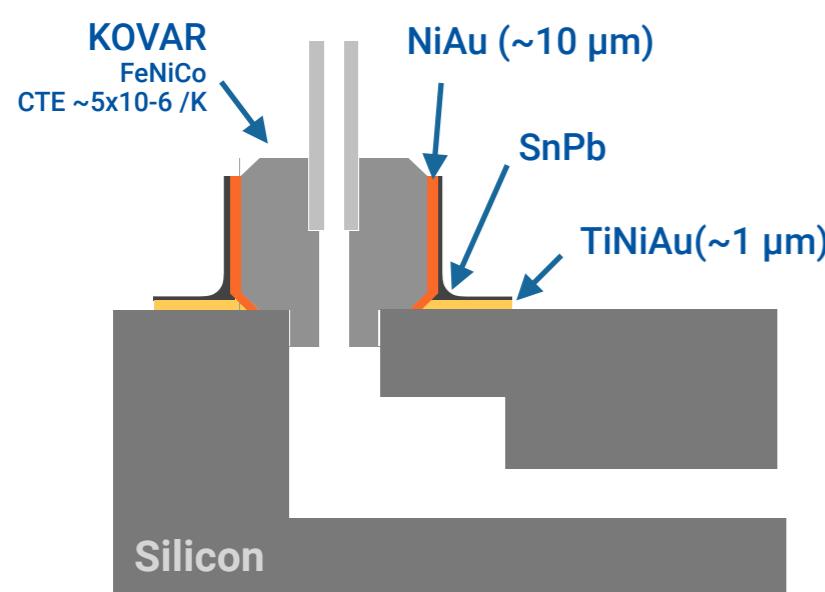


## Assembly steps:

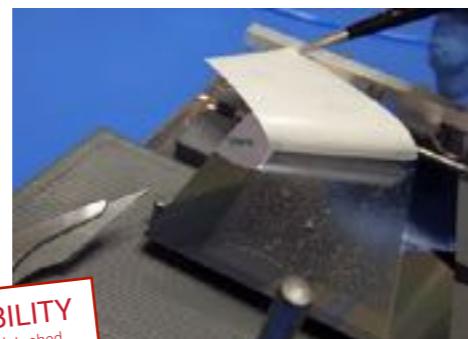
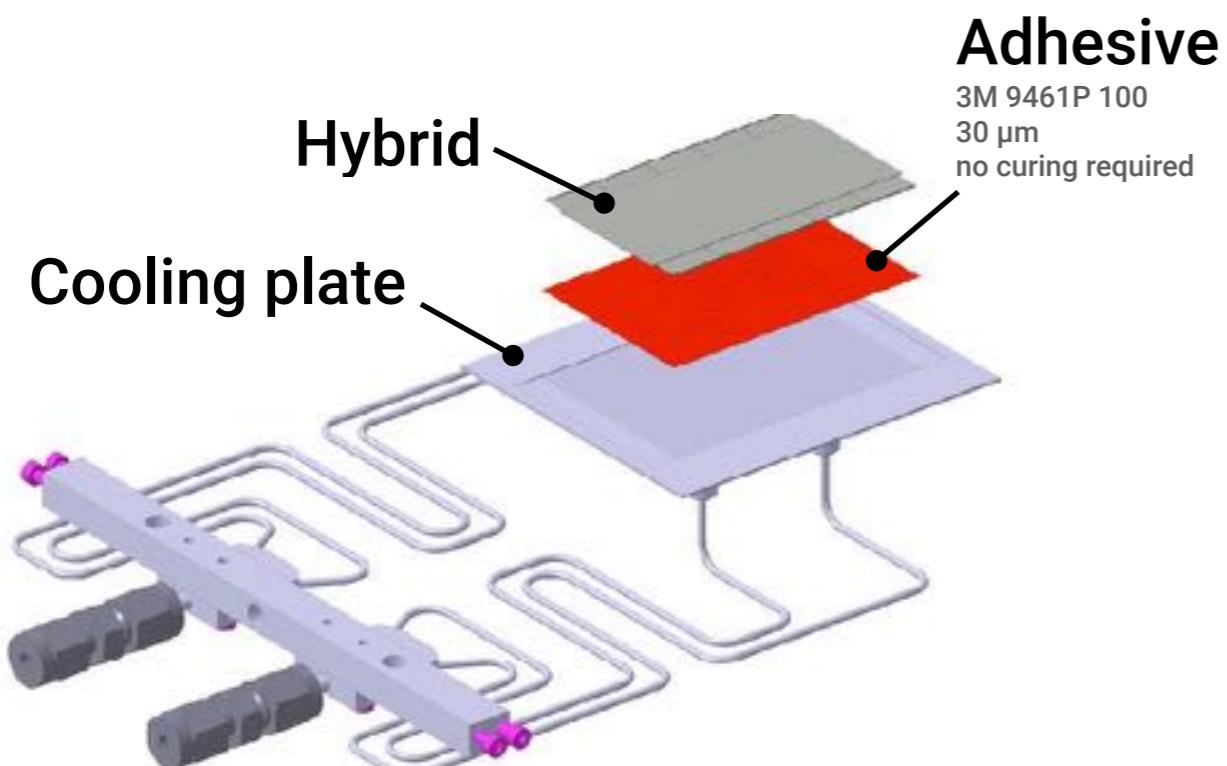
- Machining of KOVAR connectors;
- Brazing of connectors to capillaries (1);
- Bending of the capillaries;
- Brazing the other end of the capillaries to the manifolds (2);
- NiAu plating of the connectors;
- Soldering of the connectors to the silicon cooling plate (3);

## QA/QC:

- After each joining step the He leak rate is measured.  
(Acceptance leak rate:  $10_{-10}$  mbar l<sub>-1</sub> s<sub>-1</sub>).
- Pressure testing of the cooling plate at  $1.43 \times P_{op}$

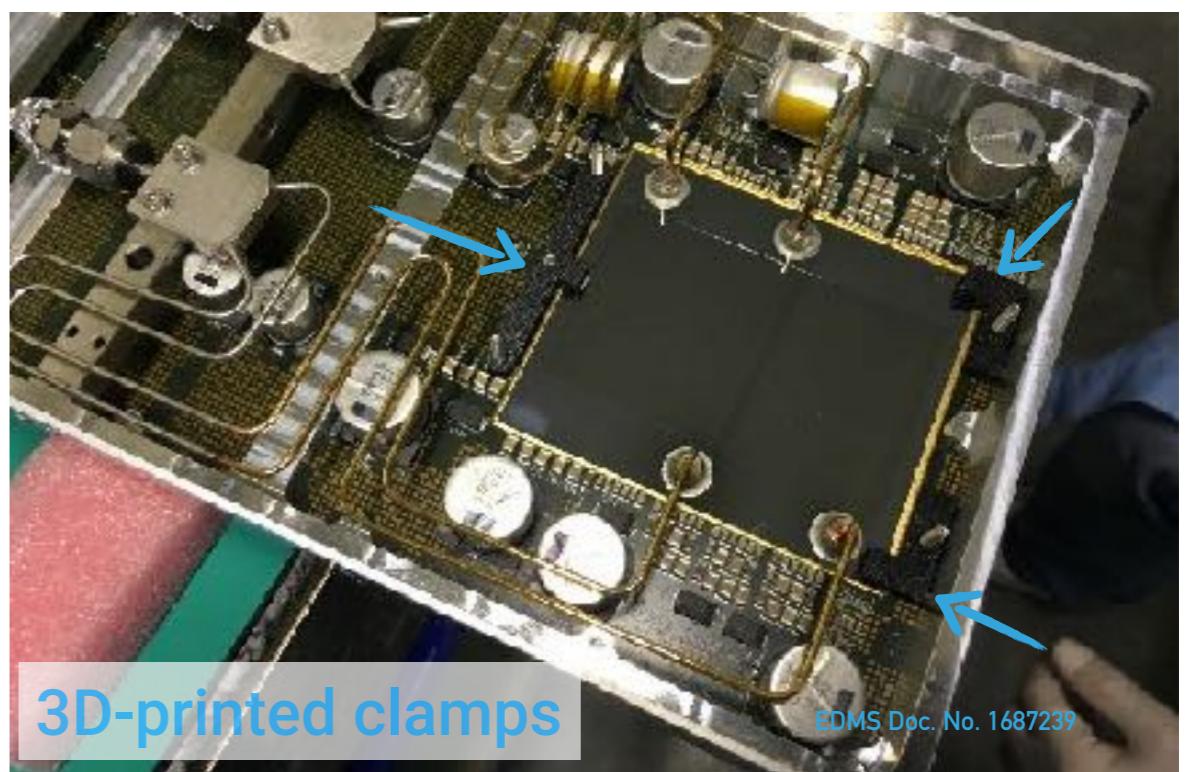
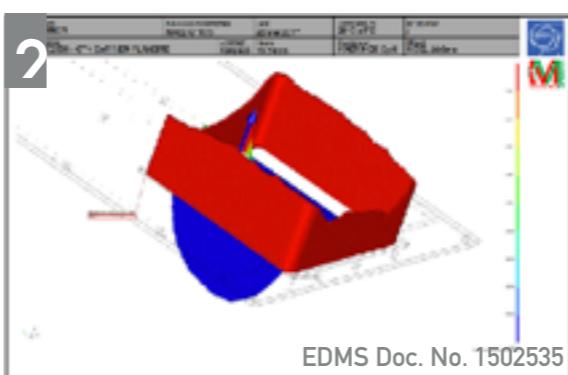
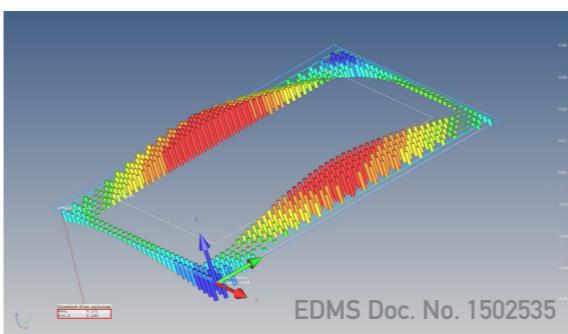


## Glueing the hybrid on the cooling plate



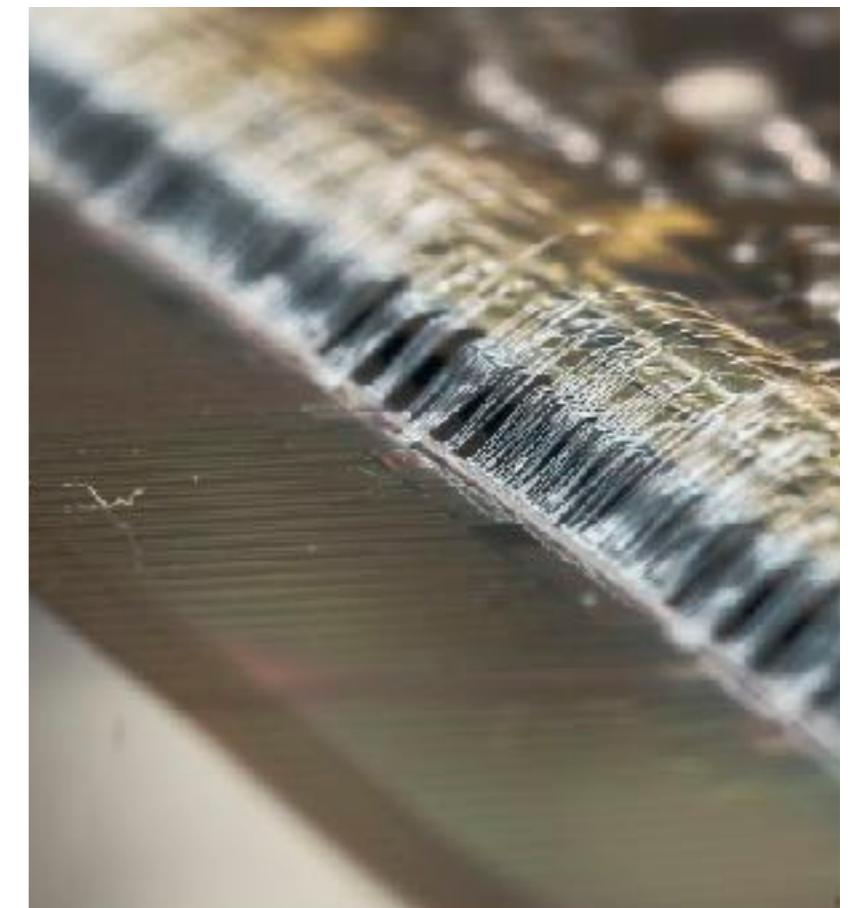
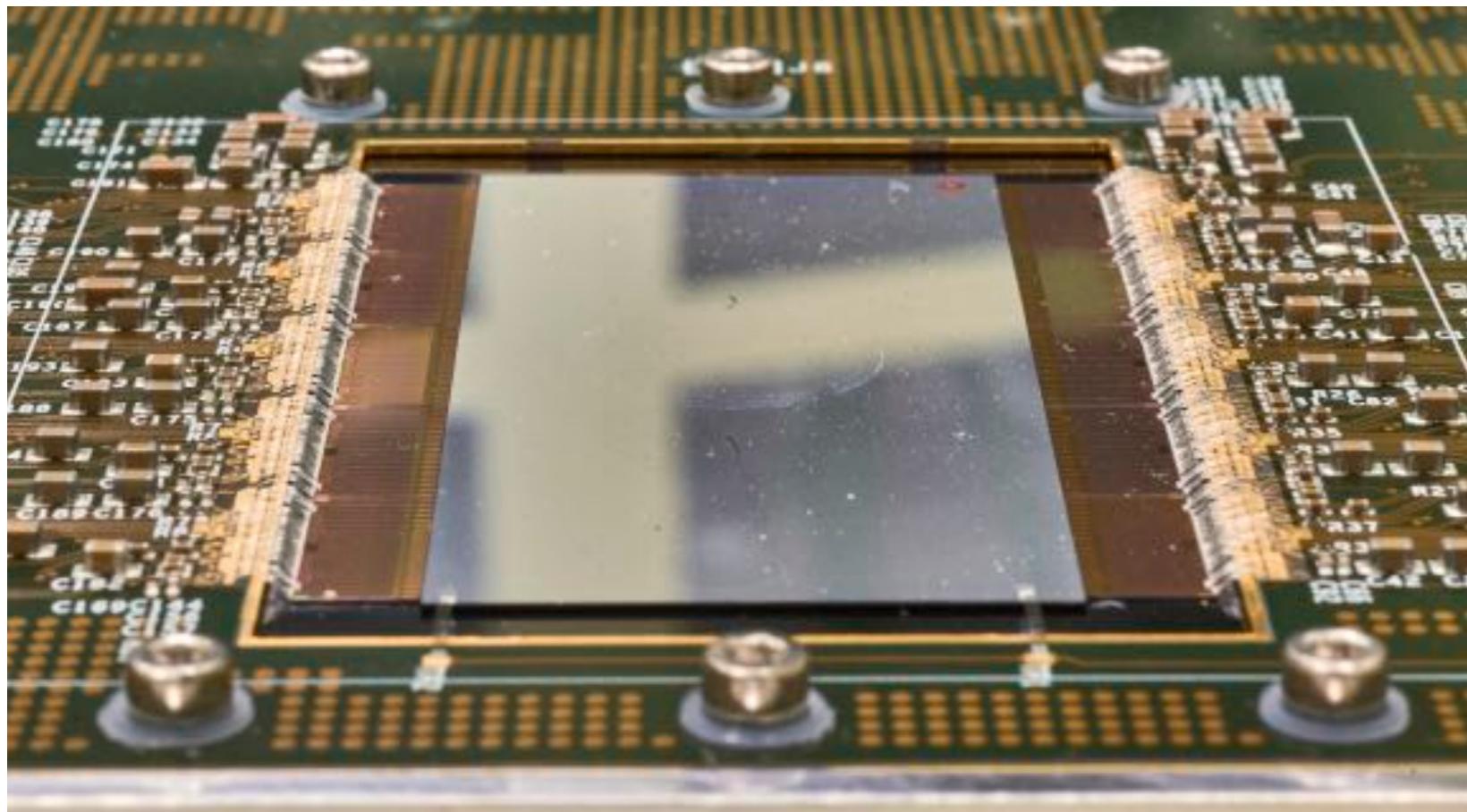
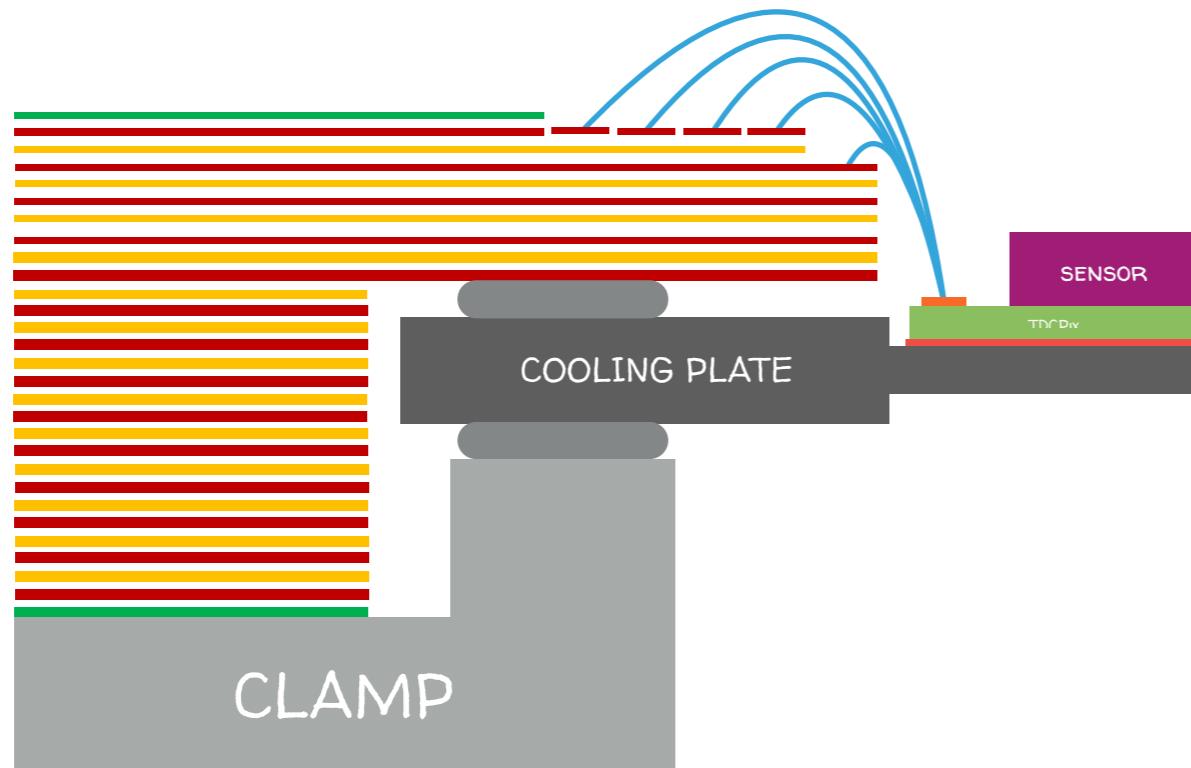
**REWORKABILITY**  
The detector can be detached from the cooling plate... or the other way around.

## Clamping the cooling plate to the PCB



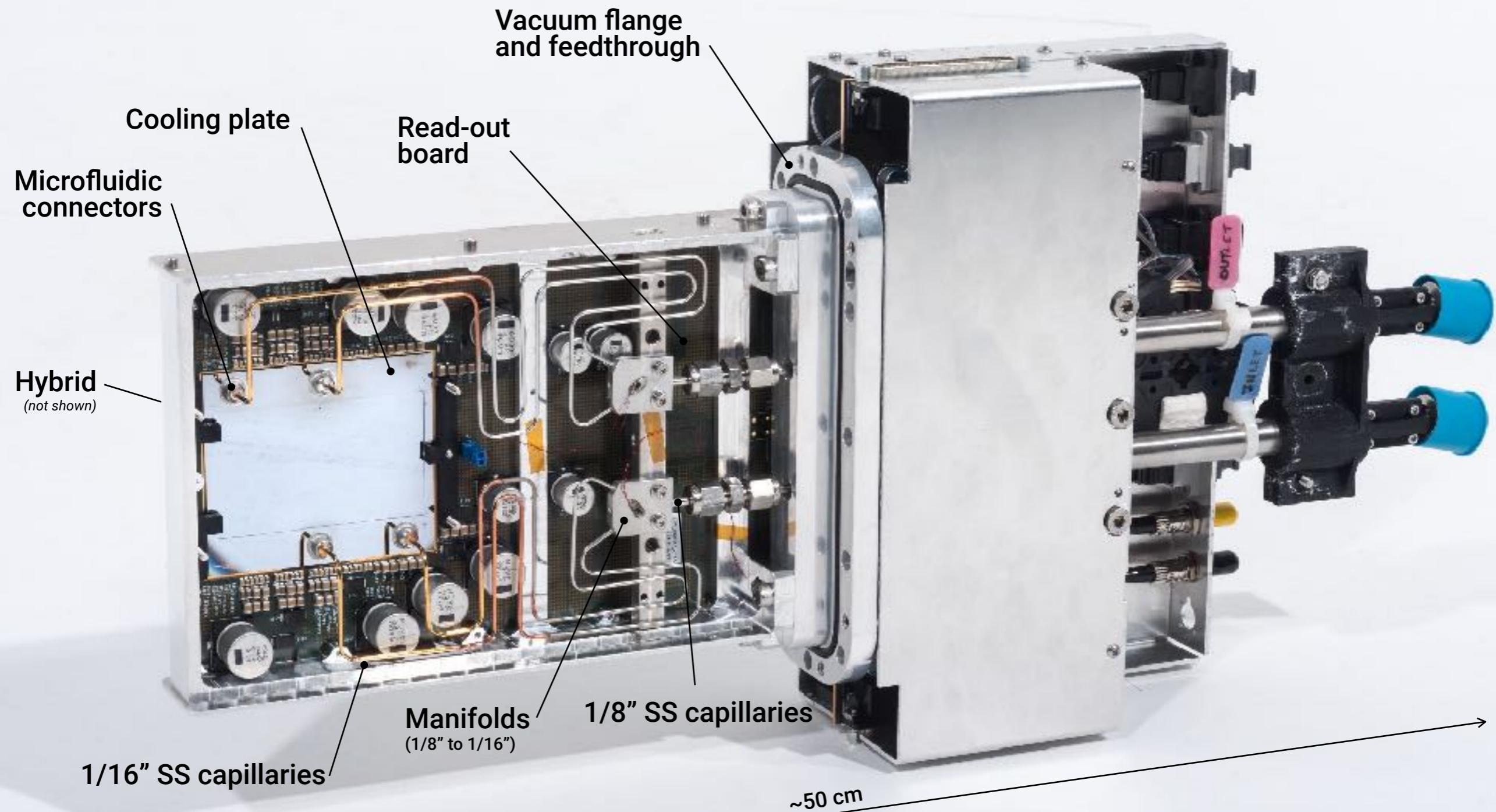
# Wire-bonding

- Performed at the CERN (<http://bondlab-qa.web.cern.ch/>)
- 18000 wire bonds per module with a pitch of 73 µm
- Critical height difference between PCB pads and TDCpix pads.



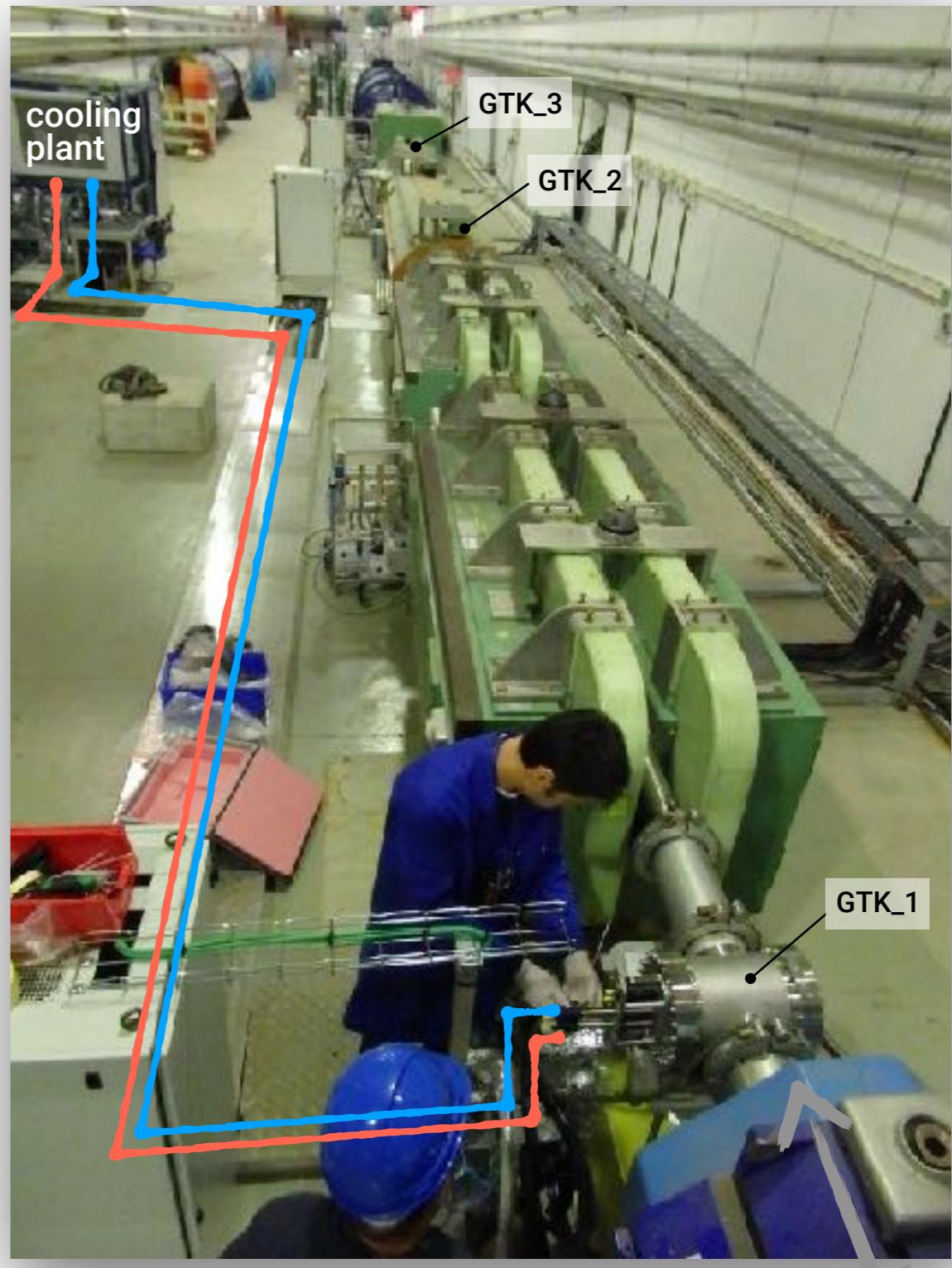
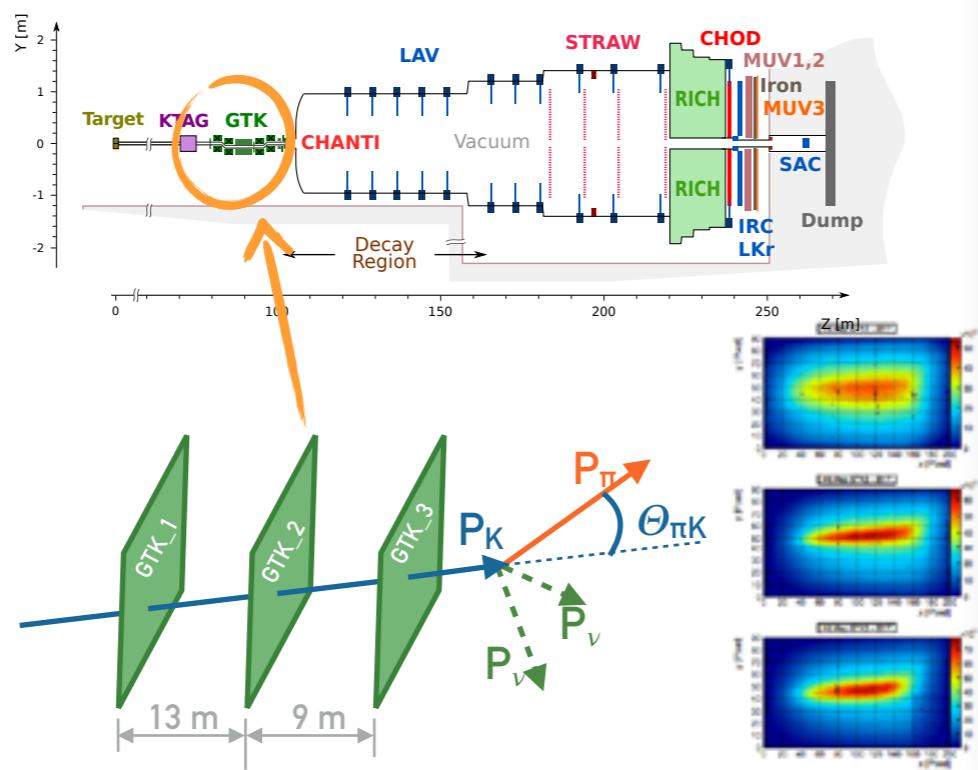


# NA62 GigaTrackEr



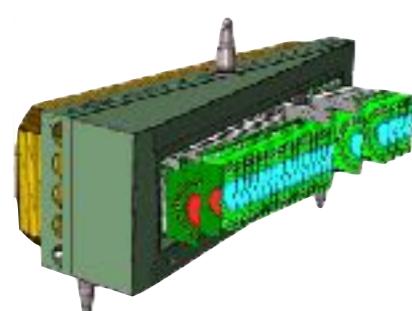
# The GTK in the NA62 experiment

- 2014 - Installation of the first GTK.
- 2016-2018 - Physics runs with 3 GTK detectors.
- 2019-2020 - (LS2) construction of the GTKs for 2021-2022.
  - At nominal beam intensity the detectors are exposed to a fluence corresponding to  $4 \times 10^{14} n_{eq}/cm^2$  in one year (200 days) of data taking.
  - In order to minimise radiation-induced damages, the detectors are operated at approximately  $-15^\circ C$  in vacuum ( $\sim 10^{-6}$  mbar).
  - Detectors have to be replaced every 100 days.
  - GTK **designed to be replaced rapidly** (<0.5 day intervention).

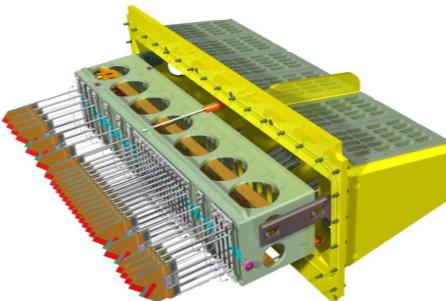
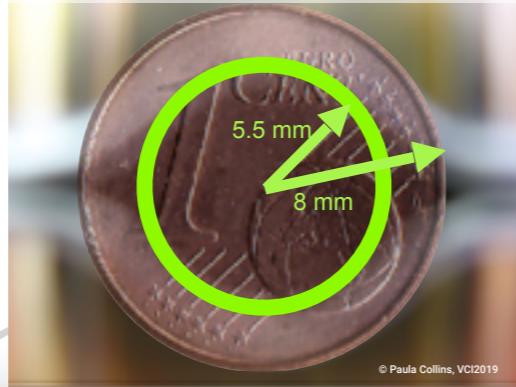


# LHCb VELO Upgrade

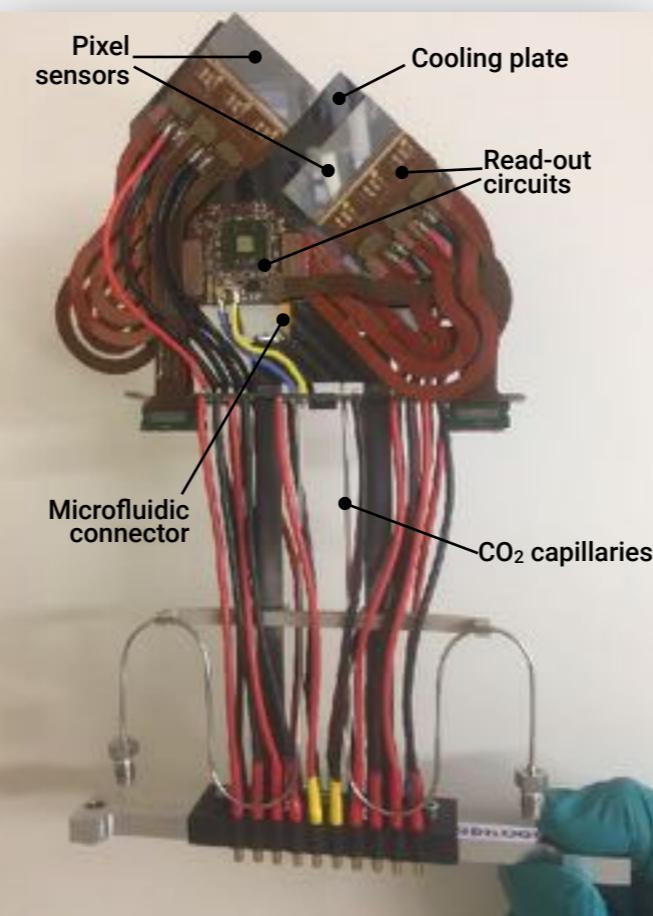
- LHCb will pioneer the use of evaporative CO<sub>2</sub> in silicon microchannels.
- The future upgrade of the LHCb's Vertex Locator (VELO) will combine in 2021 multiple silicon plates with embedded microchannels with an evaporative CO<sub>2</sub> system to cool 52 pixel modules dissipating a total of about 1.5 kW.



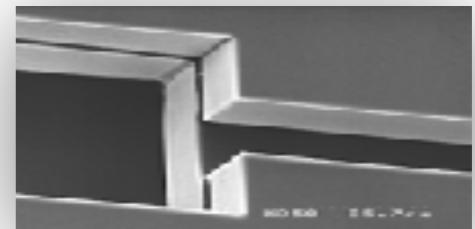
current VeLo module



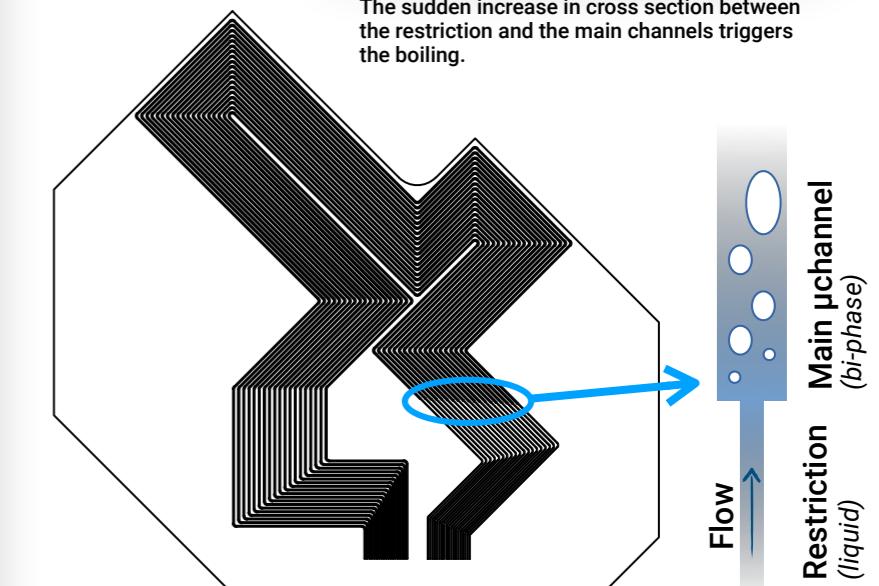
LS2 upgrade module



	current	LS2 Upgrade
modules	52	52
sensors	strip	pixel
distance to LHC beam	8 mm	5.5 mm
cooling	evap. CO <sub>2</sub>	evap. CO <sub>2</sub>
evaporator	metal blocks	silicon microchannels
module power dissipation	~ 16.5 W	~ 30 W



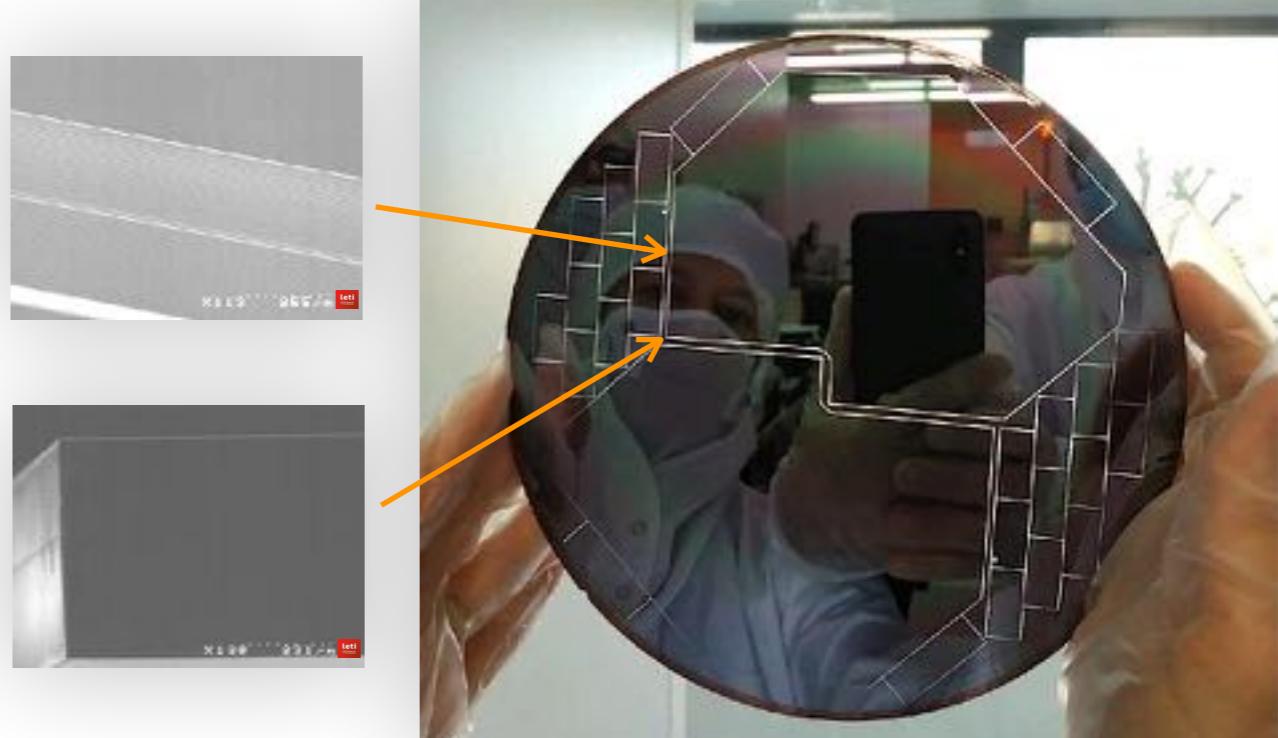
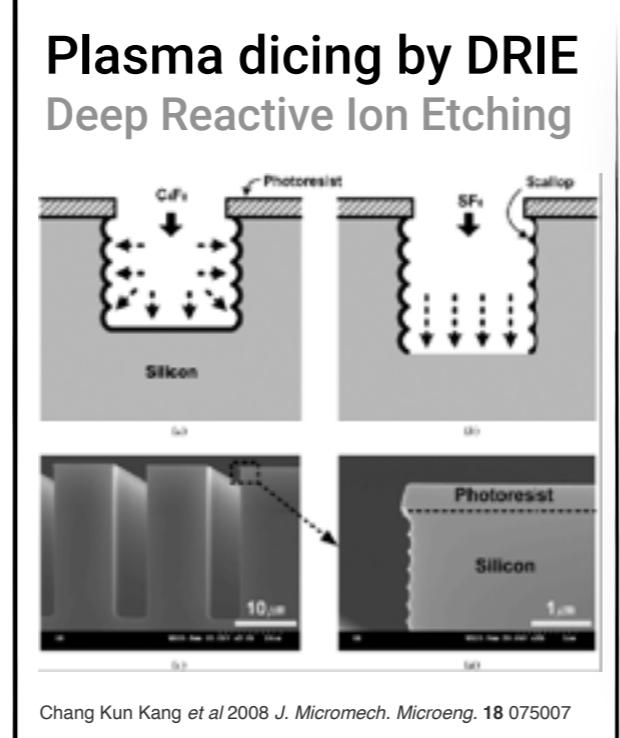
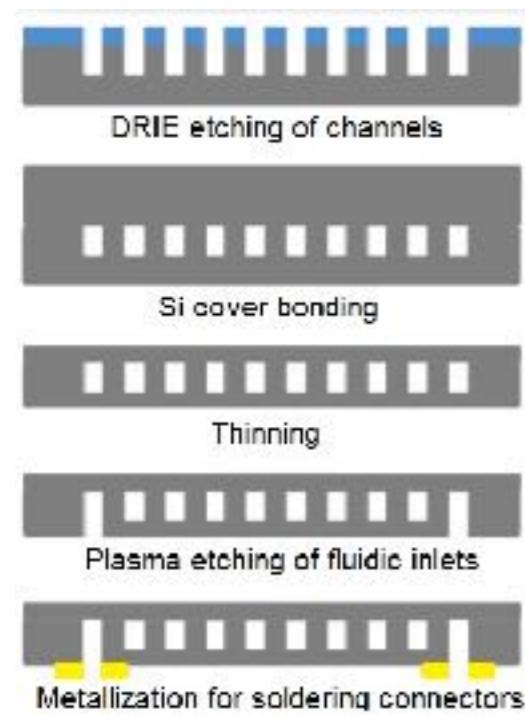
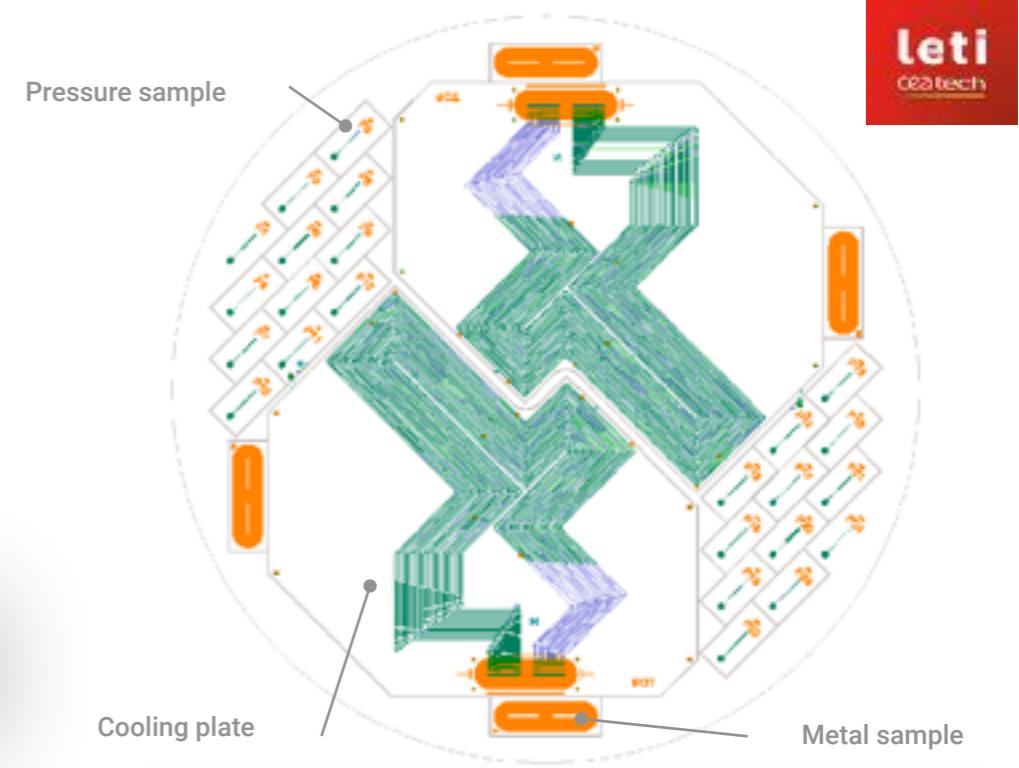
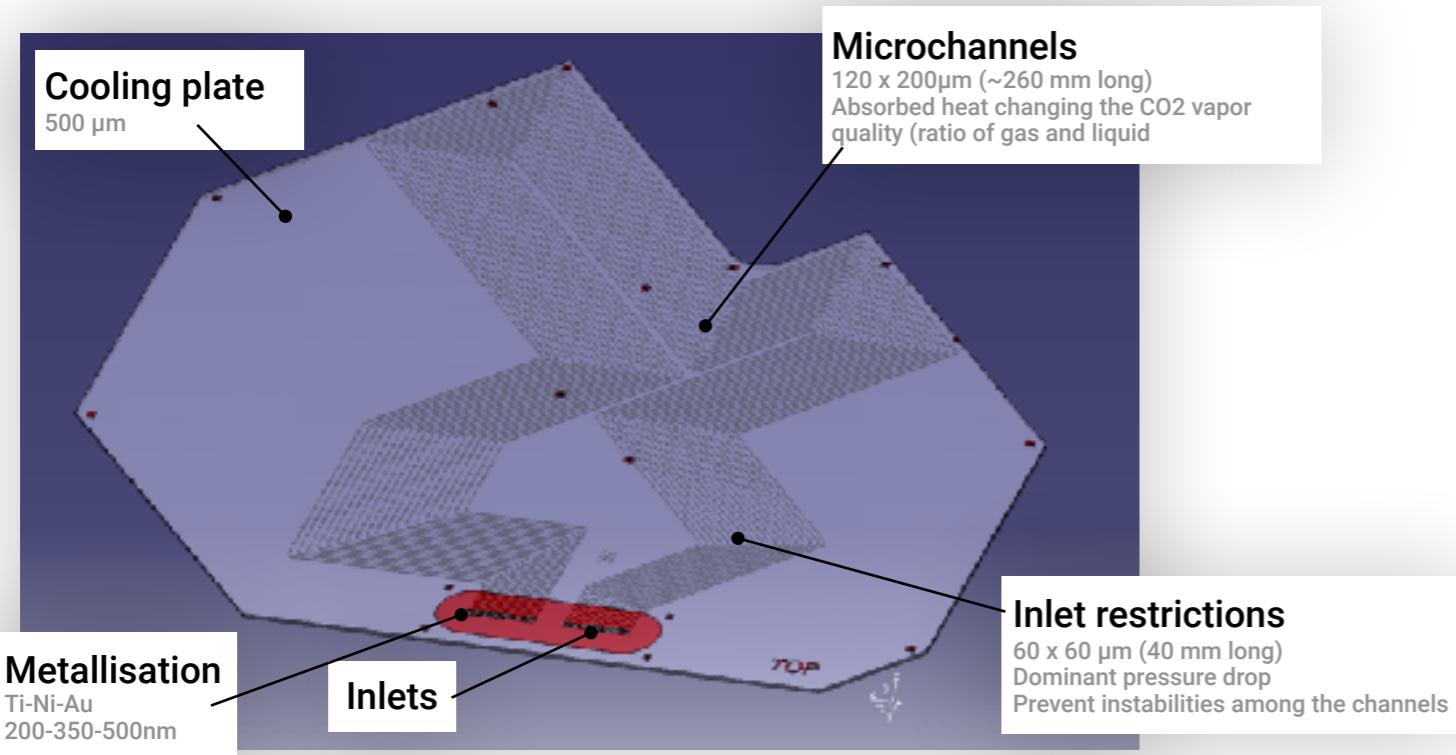
microchannel etched at different depths



Microchannels designed to bring the coolant under the heat sources.



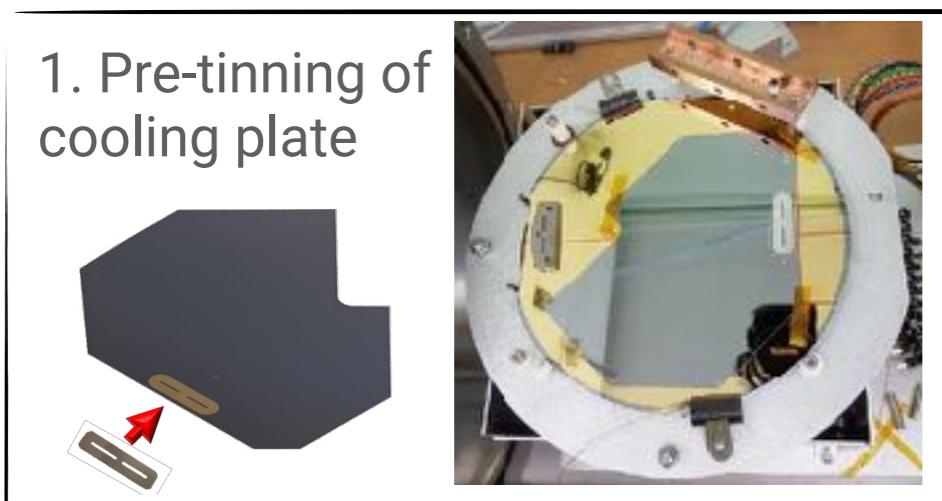
# microfabrication of the VeLo cooling plates



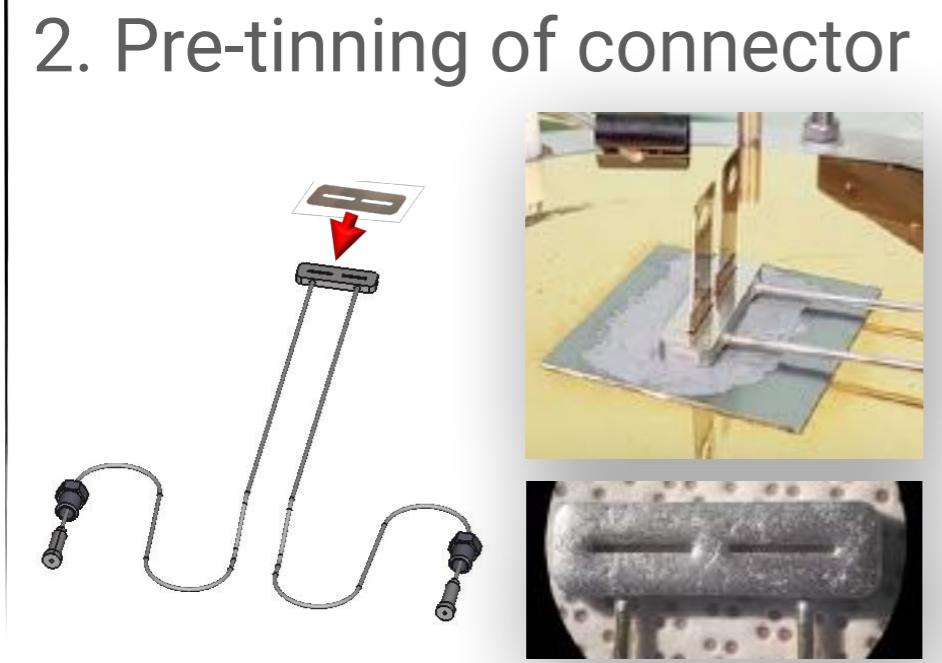
# soldering of metallic connectors



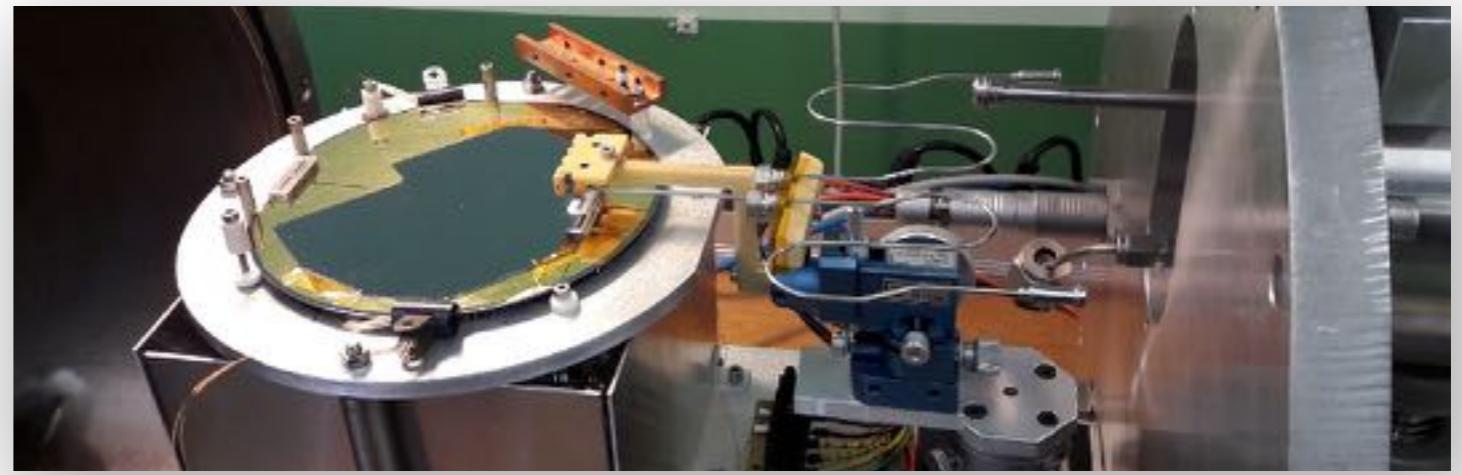
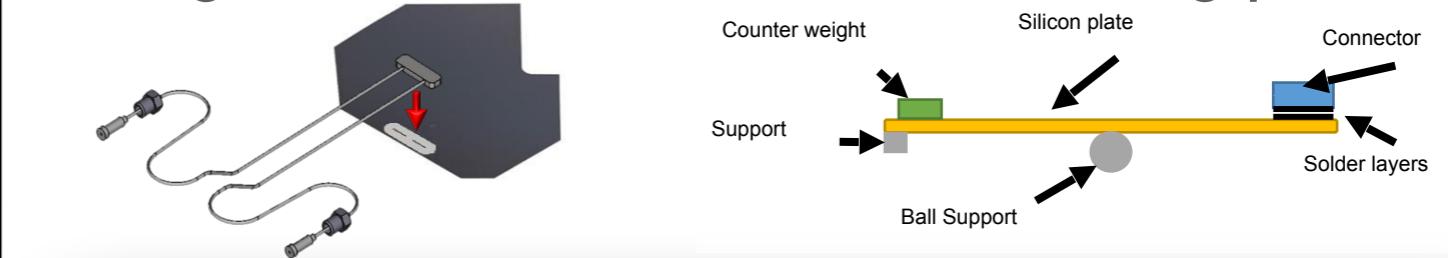
1. Pre-tinning of cooling plate



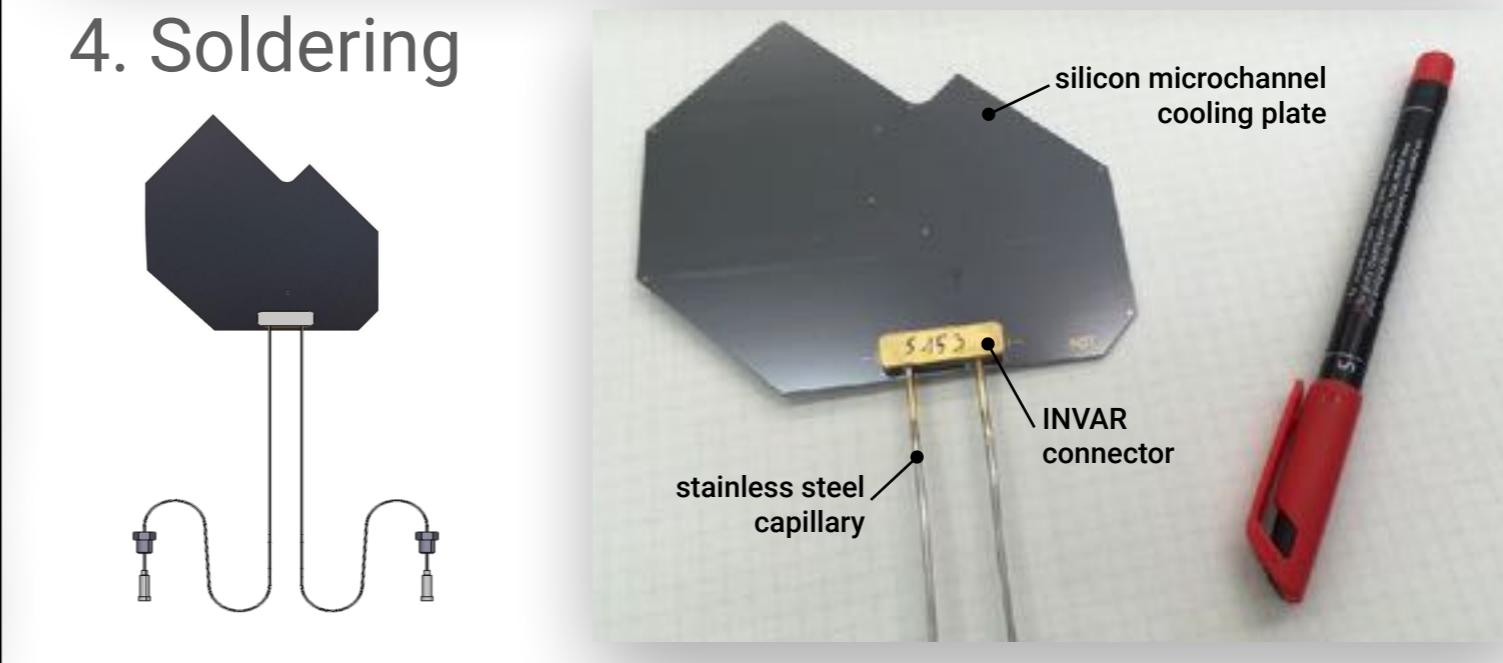
2. Pre-tinning of connector



3. Alignment of connector to cooling plate

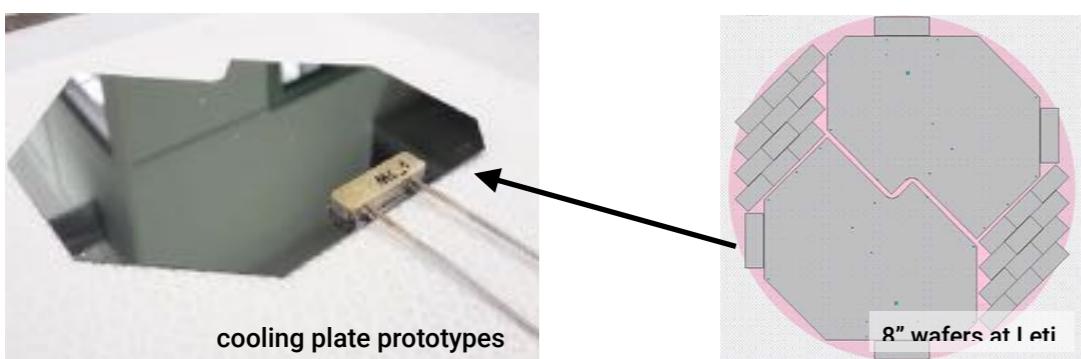
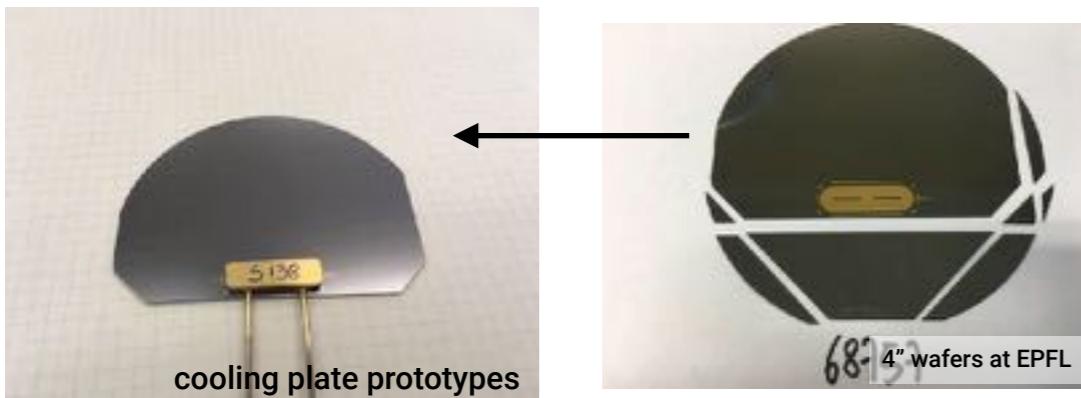
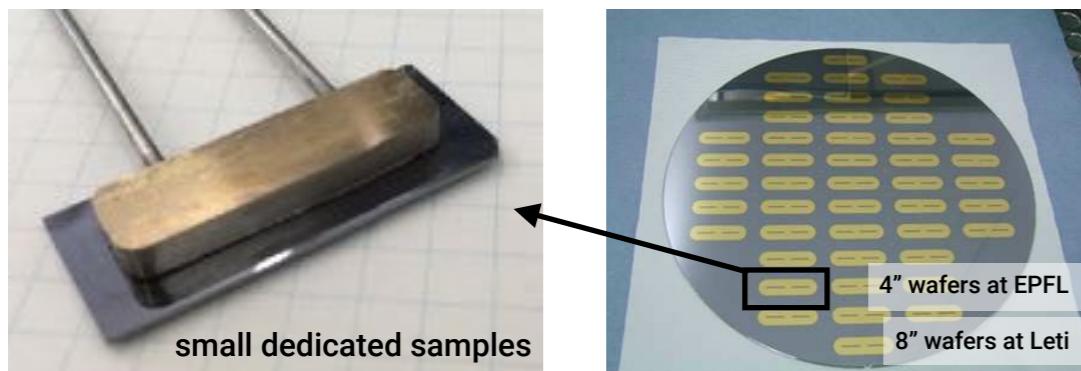
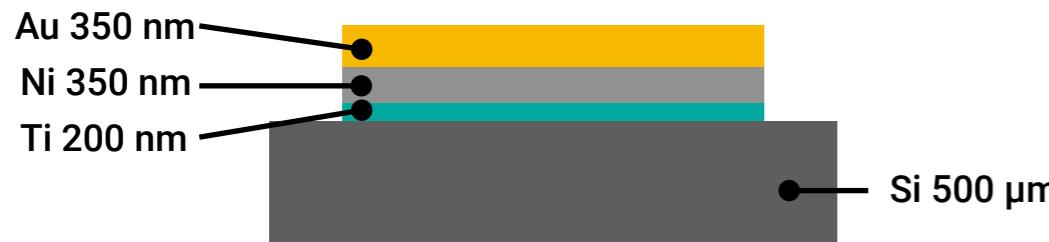


4. Soldering

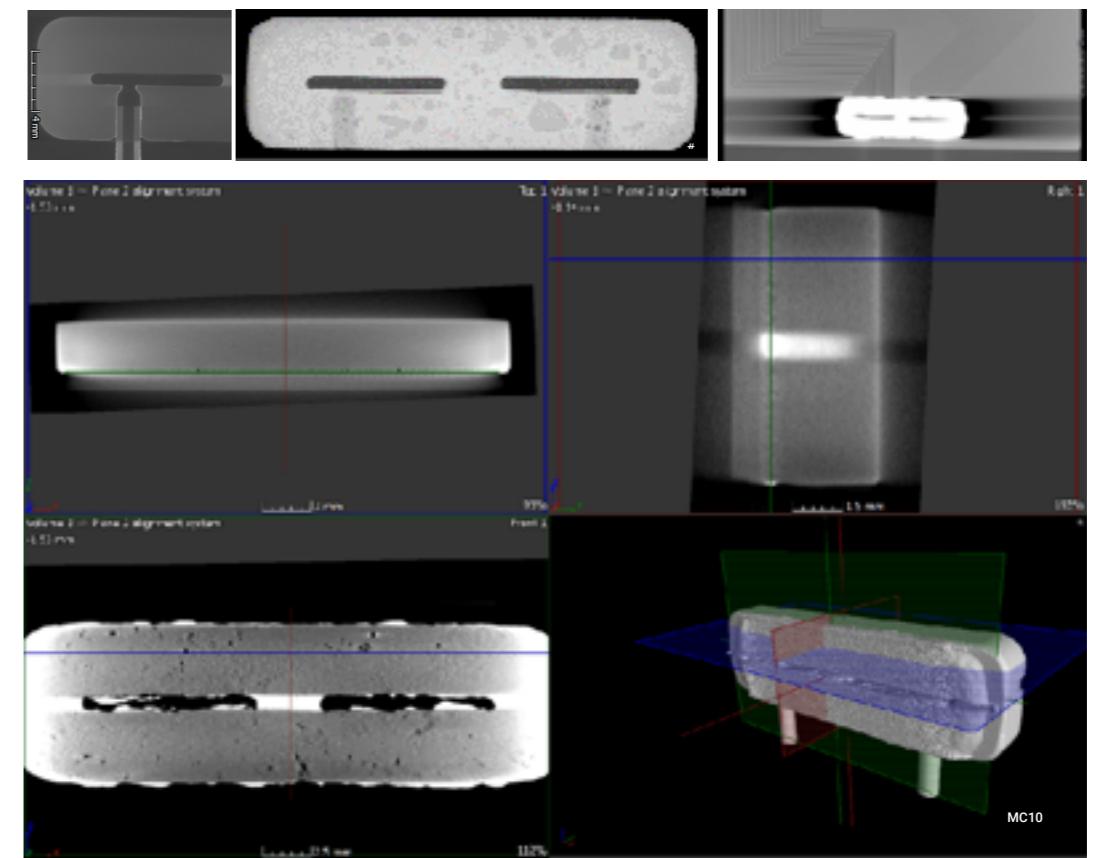
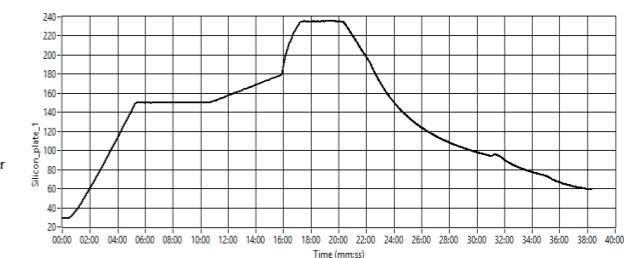
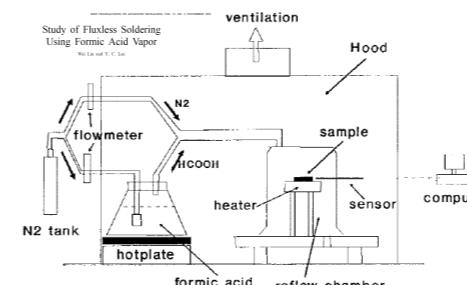


# voidless and fluxless soldering of metal to silicon

validation of soldering procedure with  
thermo-mechanical mockups

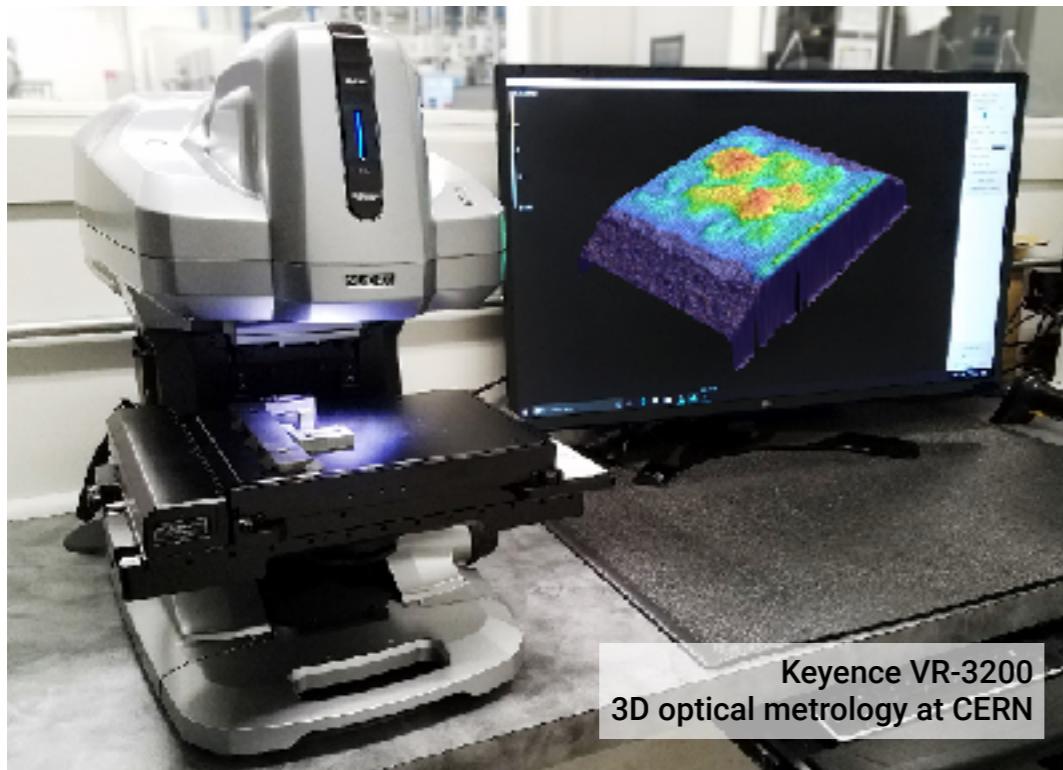


soldering in reducing atmosphere using  
Formic Acid

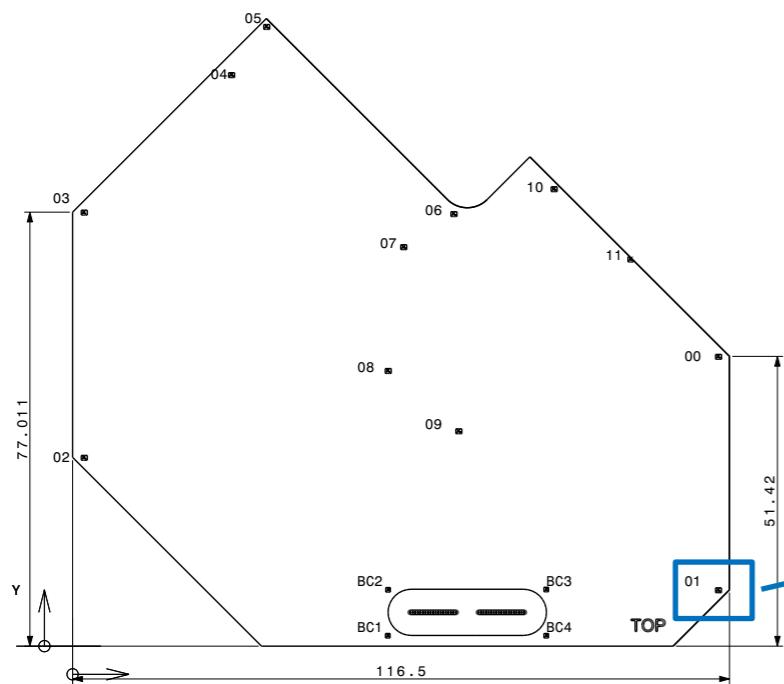
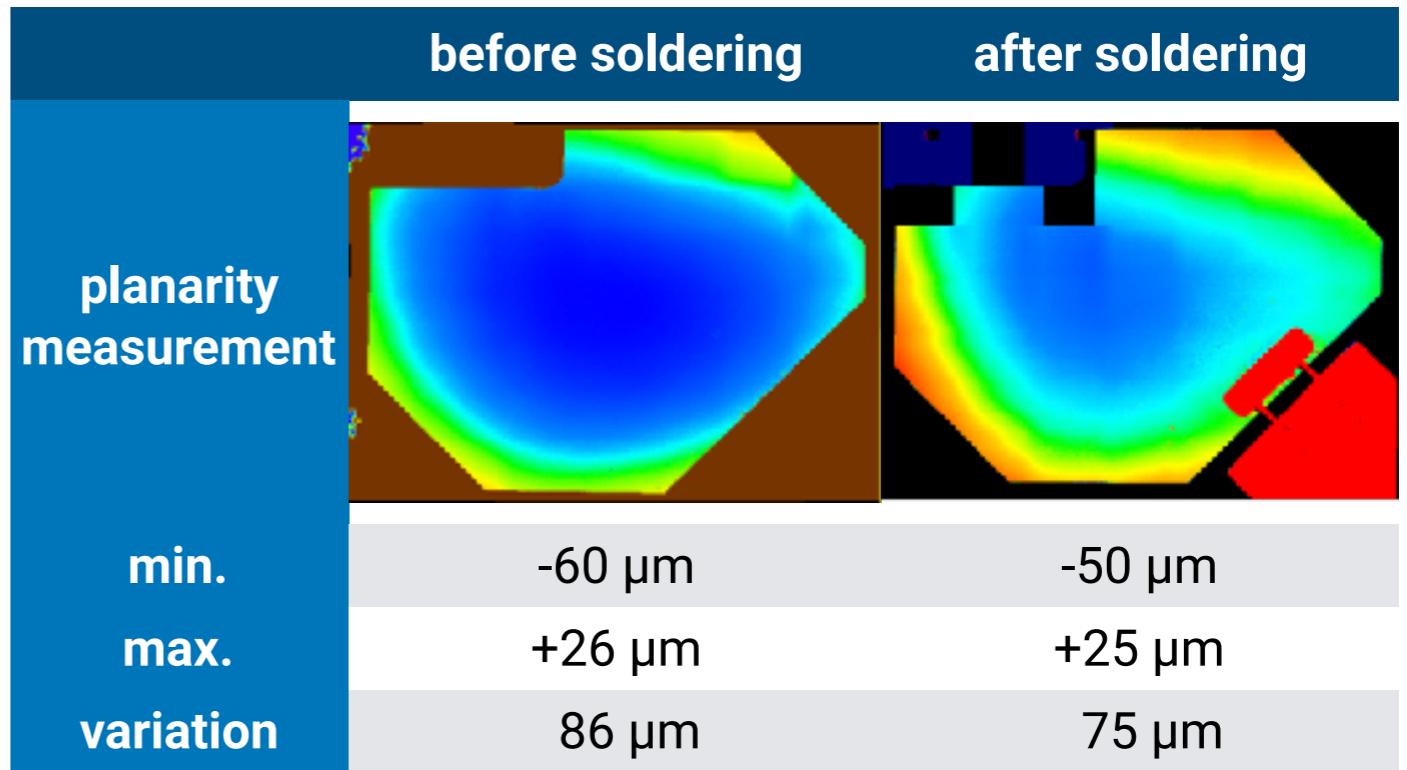


3D Xray  $\mu$ -CT at CERN

# cooling plates planarity

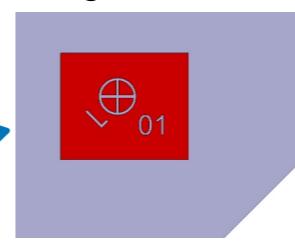


Keyence VR-3200  
3D optical metrology at CERN



- Slight change on the planarity of the cooling plates.
- No significant stress generated by the soldering.
- The cooling plate is the backbone of the mechanical assembly of the VELO module.

Alignment marks for module assembly

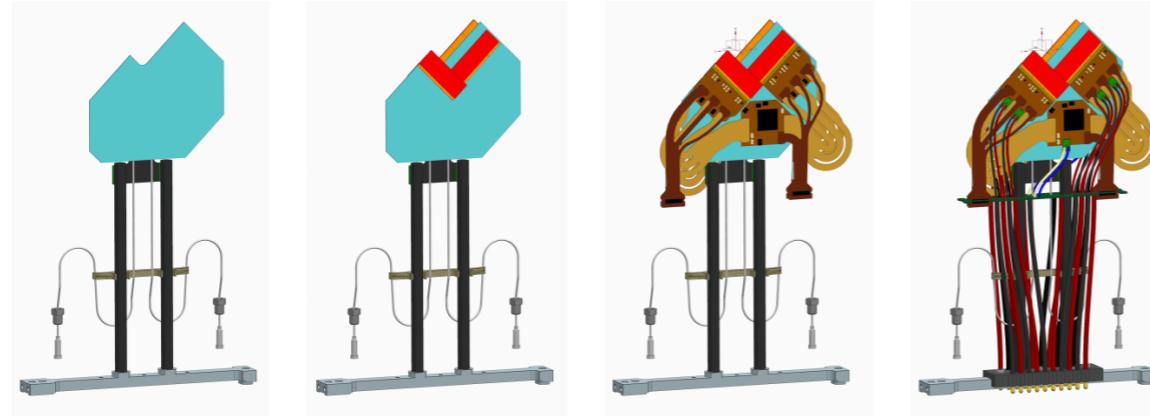


patterned on metal



etched in silicon

# VELO Upgrade Assembly and first slice

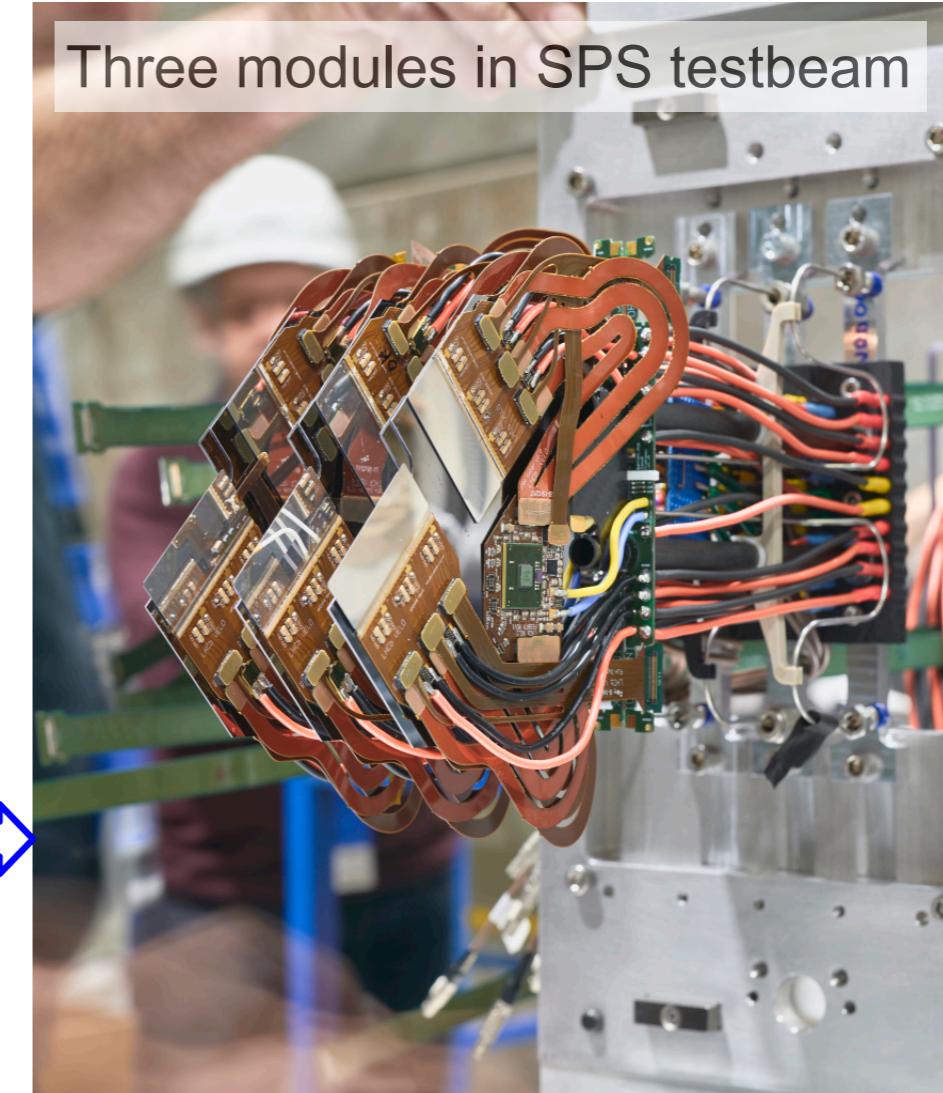
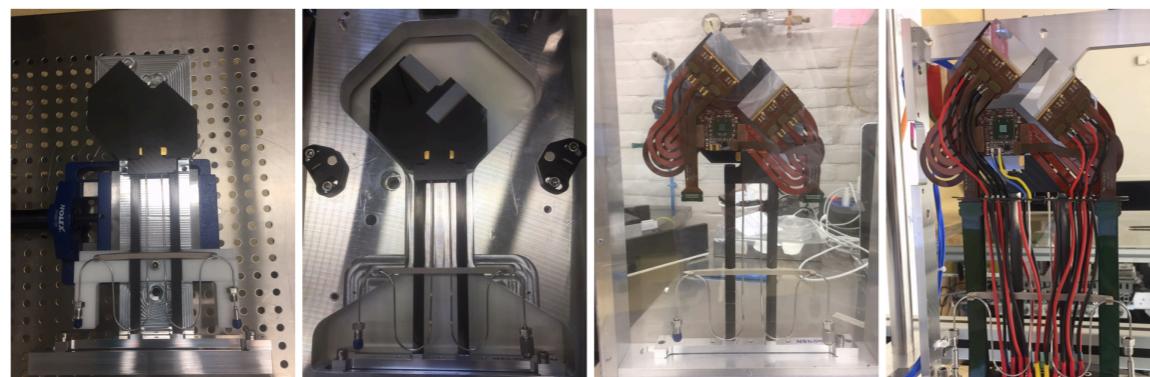


Mechanical Construction

Precision tile placement to 10  $\mu\text{m}$

Flex circuit placement

wire bonding and HV/LV/ data cable attachment



18/02/19

The LHCb VELO Upgrade Programme, VCI 2019

28

Slide from the talk **The LHCb Upgrade and the VELO** by Paula Collins at VCI2019

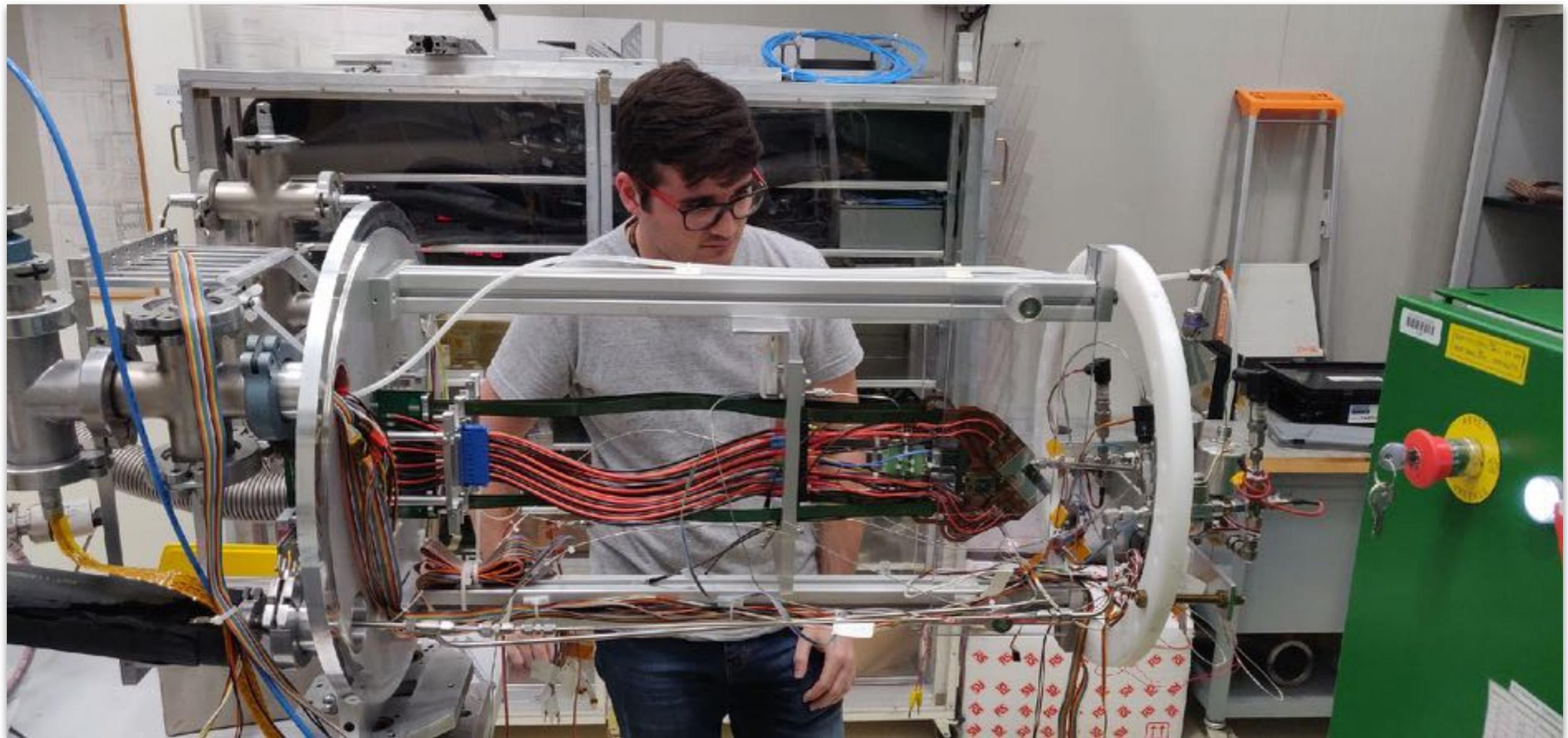


Alessandro Mapelli

20



4th Annual Meeting, 2-5 April 2019



© Oscar Augusto de Aguiar Francisco, CERN, Feb. 2019

Seminar Room 11, St Anne's College

17:00 - 17:15

Silicon-based micro oscillating heat pipes for HEP and space applications

Timothee Frei

Seminar Room 11, St Anne's College

17:15 - 17:30

Silicon microchannel cooling frames for stave configurations

Massimo Angeletti

Seminar Room 11, St Anne's College

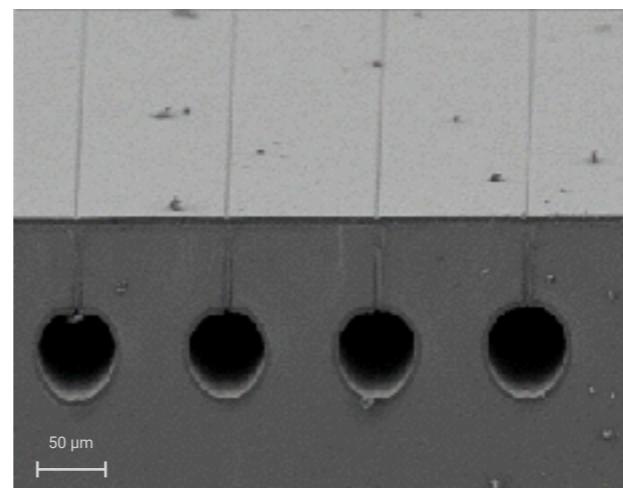
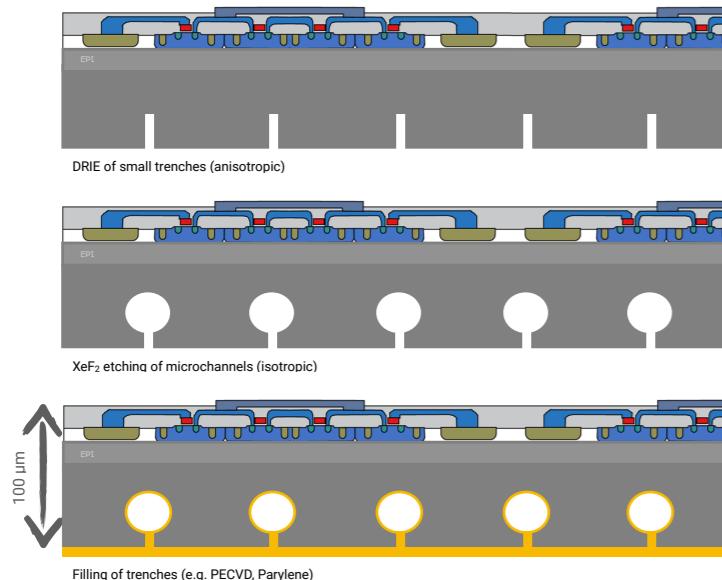
17:30 - 17:45



## *Junior Fellow: Riccardo Callegari PhD Candidate: Roberto Cardella*

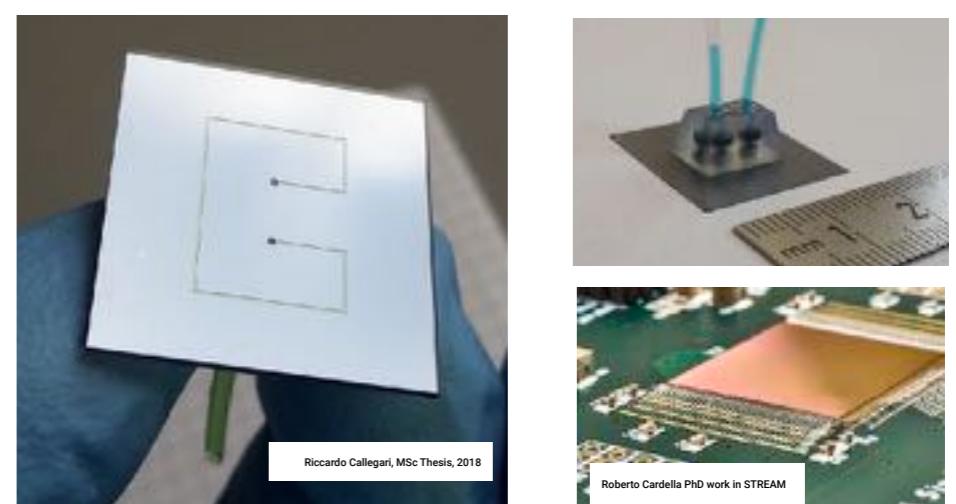
- CMOS-compatible process developed at CERN.
- Microchannels etched on the backside of monolithic pixel detectors.
- **The microchannels are sealed without wafer bonding**
- A demonstrator is currently being produced by post-processing functional MALTA\* chips in the class 100 (ISO5) MEMS cleanrooms of EPFL.

\*MALTA: an asynchronous readout CMOS monolithic pixel detector for the ATLAS High-Luminosity upgrade. R. Cardella et al., PIXEL2018



Getting rid of wafer bonding

M.J. de Boer et al./J. Microelectromechanical Systems 9 (1) (2000) 94-103  
M. Boscardin et al./Nuclear Instruments and Methods in Physics Research A 718 (2013) 297-298  
C. Lipp, EPFL MSc Thesis, 2017  
R. Callegari, Università di Genova, MSc Thesis, 2018



Alessandro Mapelli

**Silicon-based micro oscillating heat pipes for HEP and space applications**

Timothée Frei

Seminar Room 11, St Anne's College

17:15 - 17:30

Silicon microchannel cooling frames for stave configurations

Massimo Angeletti

Seminar Room 11, St Anne's College

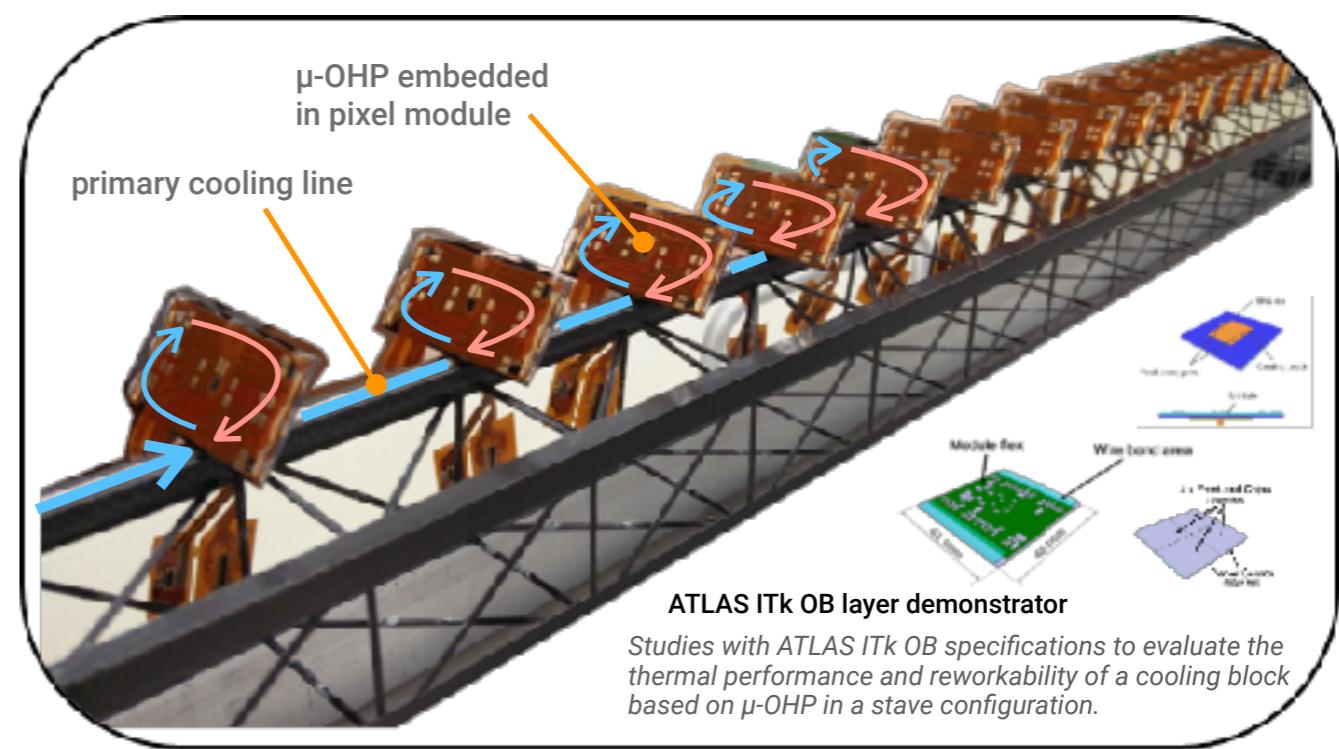
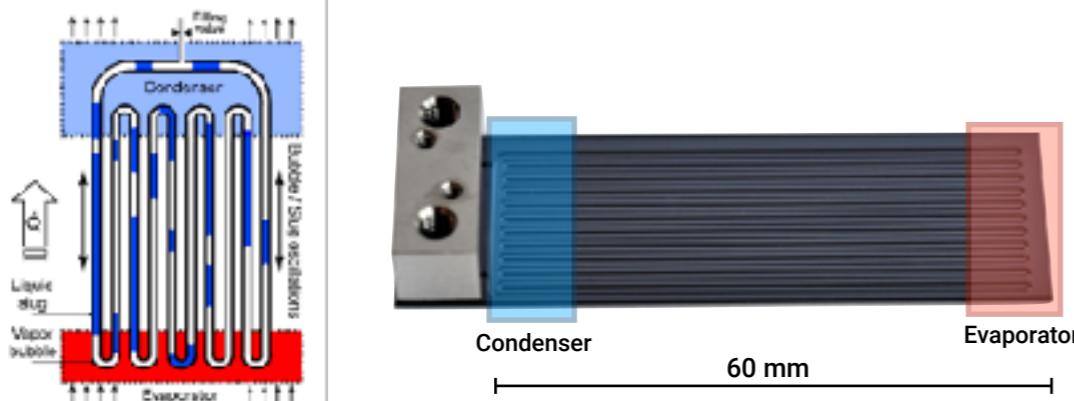
17:30 - 17:45



*PhD candidate: Timothée Frei*

# Getting rid of the connectors

- Miniaturised closed loop device operated in stand-alone mode.
- Self-contained and self-actuated.
- **Eliminate connectors**
- MEMS Heat Pipes Review (EDMS Doc No [1852809](#)).



Embedding microfluidics into microelectronics

Riccardo Callegari

Seminar Room 11, St Anne's College

17:00 - 17:15

Silicon-based micro oscillating heat pipes for HEP and space applications

Timothee Frei

Seminar Room 11, St Anne's College

17:15 - 17:30

**Silicon microchannel cooling frames for stave configurations**

Massimo Angeletti

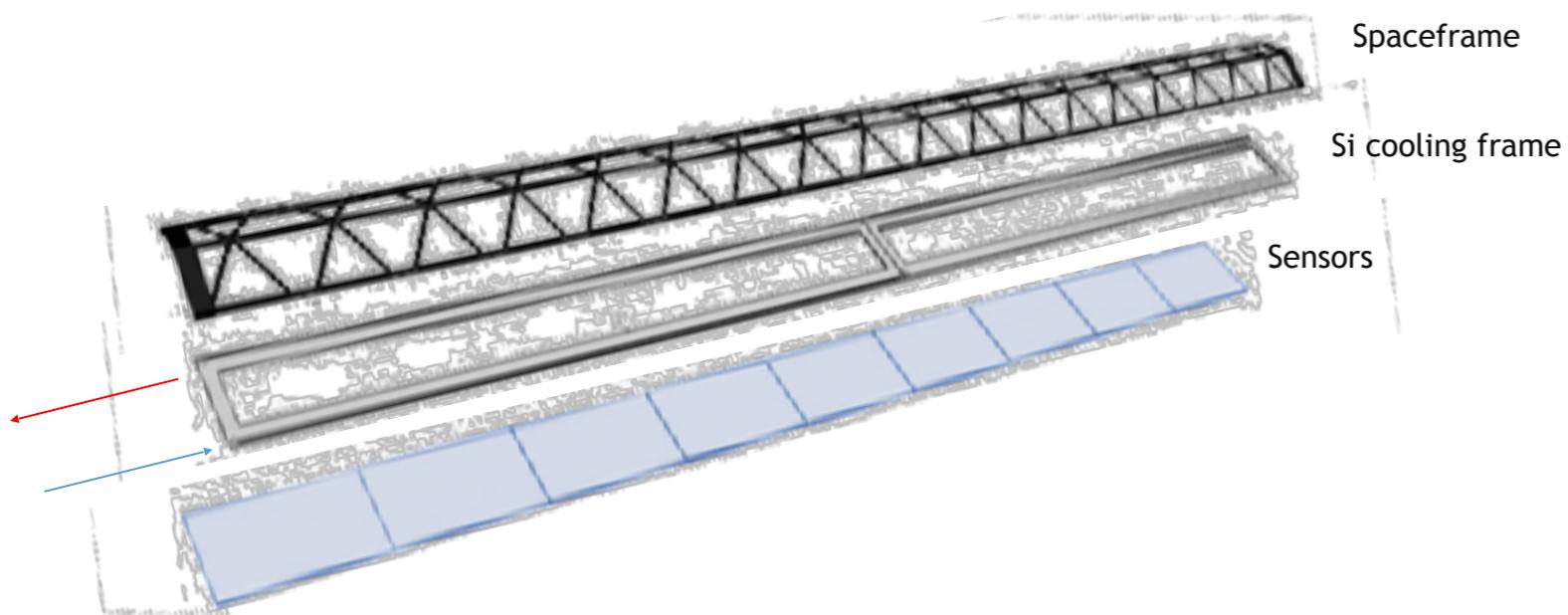
Seminar Room 11, St Anne's College

17:30 - 17:45



*PhD candidate: Massimo Angeletti*

Getting rid of the plate



Alessandro Mapelli

# conclusions and outlook

- The NA62 experiment has pioneered the use of silicon microchannel cooling plates with **liquid C<sub>6</sub>F<sub>14</sub>** for the thermal management of the **GTK pixel detectors**.
- The LHCb experiment will pioneer the use of **evaporative CO<sub>2</sub>** in silicon microchannels for the **LS2 Upgrade of the VELO**.
- Current developments at CERN are aiming at:
  - eliminating connectors with **stand-alone microfluidic circuits** such as heat pipes;
  - **embedding the microchannels into monolithic** pixel detectors with **CMOS-compatible microfabrication** processes;
  - **reducing the material budget with frames** instead of cooling plates;
  - developing **interconnection solutions to cover larger areas** such as staves.

100 µm  